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## Smart Power Module, 600V SPM3<sup>®</sup> Ver6, Series Application Note



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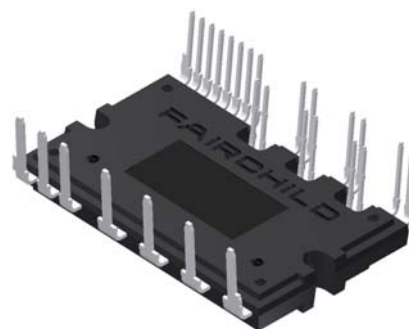
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### 1. Introduce

This application note supports the 600V SPM3 version 6 series. It should be used in conjunction with SPM3 datasheets, Onsemi IPM design reference guidance ([RD-572](#)), and application note [AN-9086 \(Mounting Guidance\)](#)

#### 1.1. Design Concept

The SPM3 design objective is to provide a minimized package and a low power consumption module with improved reliability. This is achieved by applying new gate-driving High-Voltage Integrated Circuit (HVIC), a new Insulated-Gate Bipolar Transistor (IGBT) of advanced silicon technology, and improved Direct Bonded Copper (DBC) substrate base transfer mold package. The SPM3 achieves reduced board size and improved reliability compared to existing discrete solutions. Target applications are inverter motor drives for industrial use, such as air conditioners, general-purpose inverters and serve motors. The temperature sensing function of SPM3 version 6 products is implemented in the LVIC to enhance the system reliability. An analog voltage proportional to the temperature of the LVIC is provided for monitoring the module temperature and necessary protections against over-temperature situations. The right figure show the package outline structure.



#### APPLICATION NOTE

#### 1.2. Key Features

- 600 V 30 A 3-Phase IGBT Inverter Including Control ICs for Gate Driving and Protections
- Very Low Thermal Resistance by Adopting DBC Substrate
- Easy PCB Layout due to Built-in Bootstrap Diodes
- Divided Negative DC-Link Terminals for Inverter Three-Leg current Sensing
- Single-Grounded Power Supply due to Built-in HVICs and Bootstrap Operations
- Built-in Temperature Sensing Unit of IC
- Isolation Rating of 2500 VRMS/min

## 2. Product description

### 2.1. Ordering information

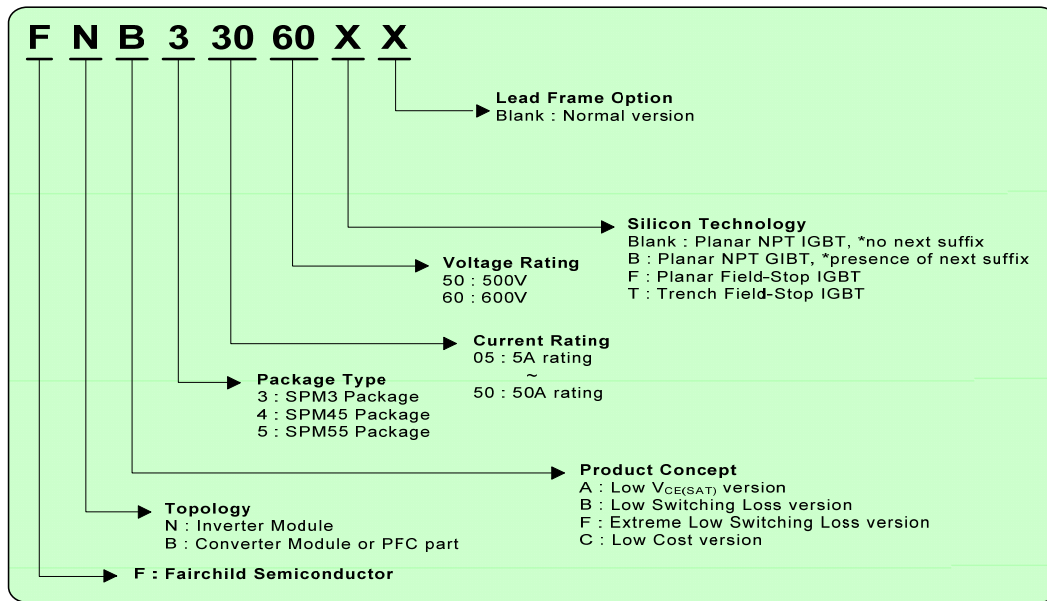


Figure 1. Ordering information of SPM®3 V6

### 2.2. Product Line-up

Table 1 shows the basic line up without package variations. Online loss and temperature simulation tool, Motion Control Design Tool is recommended to find out the right SPM product for the desired application

Table 1. Product Line-up

Target Application	Device	IGBT Rating	Motor Rating <sup>(1)</sup>	Isolation Voltage
Air Conditioners, Industrial Motor, General-purpose inverters, Servo motors	FNB33060T	30 A / 600 V	2.2 kW	$V_{ISO} = 2500 V_{RMS}$ (Sine 60 Hz, 1-min All Shorted Pins Heat Sink)
	FNB34060T	40 A / 600 V	3.0kW	
	FNB35060T	50 A / 600 V	3.7kW	

**Notes:**

- These motor ratings are general ratings, so may be changed by the operation conditions.

### 2.3. SPM3 Version Comparison

As it can be seen from Table 2, SPM3 Version 6 products have at least the same or lower  $V_{CESAT\_MAX}$  compared with the predecessors. Old version products were not released at the same time, and, therefore, there are differences even within the same version products. This version 6 product is the first version in which all the line-up was released at the same with consistent features.

The 600V SPM 3 version 6 products are much more rugged than previous versions in many aspects.

- $V_{DD-Com}$  and  $V_B-V_S$  surge noise immunity level increased about 50%. In other words, when a single surge pulse comes in between these pins, Version 2 products can endure 50% higher level of surge voltage without malfunction.
- Destruction level against surge pulses consecutively coming in between  $V_B$  and  $V_S$  improved significantly.

It should be noted that quiescent current of  $V_{DD}$  increased because of TSU function. It does not affect much on selecting the bootstrap capacitor value, but the stand-by power increased by about 2.1mW. There is no change in quiescent current of  $V_{BS}$ .

**Table 2. SPM3 Version Comparison**

SPM3 Version		Version 4		Version 5	Version 6
IGBT Silicon Tech		Planar NPT IGBT		Planar(15, 20 A) / Trench (30 A) NPT IGBT	Trench Field Stop IGBT
Substrate		Full Pack	DBC	Only DBC	Only DBC
Current Rating / $V_{CESAT}$	5 [A]	FSBF5CH60B / 2.0 [V]	-	-	-
	10 [A]	FSBF10CH60B / 2.0 [V]	-	-	-
	15 [A]	-	FSBB15CH60C / 2.0 [V]	FSBB15CH60D / 2.0 [V]	-
	20 [A]	-	FSBB20CH60C / 2.0 [V]	FSBB20CH60D / 2.0 [V]	-
	30 [A]	-	FSBB20CH60C / 2.4 [V]	FSBB30CH60D / 2.1 [V]	FNB33060T / 1.6 [V]
	40 [A]	-	-	-	FNB34060T / 1.5 [V]
	50 [A]	-	-	-	FNB35060T / 1.65 [V]
$V_S$ -Output		Inner Bonding		Inner Bonding	Inner Bonding
Bootstrap Diode		O		O	O
OC/UV Protection		O		O	O
Thermal Sensing		X		O	O

### 3. Package

#### 3.1. Internal Circuit Diagram

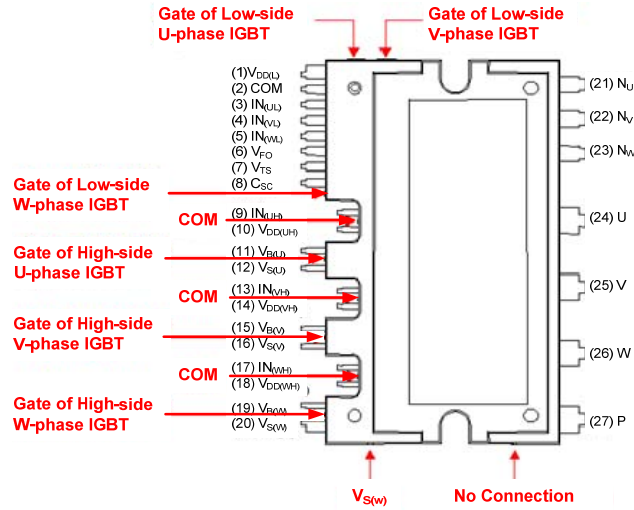
Major differences between SPM<sup>®</sup>3Version 6 and previous versions are colored in red in the internal circuit diagram as shown in Figure 2. Even though some old versions also have these features, Version 6 is the second version which widely adopts these features. Main difference was changed from CFOD to  $V_{TS}$ . The  $V_{TS}$  pin is from LVIC and gives out the temperature sensing signal.

SPM3 Version	Version 4	Version 5&6
Internal Circuit Diagram		
Difference Point	Inner Bonding and add to Bootstrap diode base on Version 2	Changed from CFOD to $V_{TS}$ base on Version 4

**Figure 2. SPM3 Version Comparison Internal Circuit**

### 3.2. Pin Description

Figure 3 shows the location of pins, the names and dummy pins of SPM3 series.



**Figure 3. Pin Numbers, Names and Dummy Pins**

In the later section illustrates the internal structure of the module in more detail. The detail functional descriptions are provided in Table 3.

**Table 3. Pin Description**

Pin Number	Name	Description
1	$V_{DD(L)}$	Low-Side Bias Voltage for IC and IGBT Driving
2	COM	Common Supply Ground
3	$IN_{(UL)}$	Signal Input for Low-Side U Phase
4	$IN_{(VL)}$	Signal Input for Low-Side V Phase
5	$IN_{(WL)}$	Signal Input for Low-Side W Phase
6	$V_{FO}$	Fault Output
7	$V_{TS}$	Output for LVIC Temperature Sensing Voltage
8	$C_{SC}$	Shunt down input for over current protection
9	$IN_{(UH)}$	Signal Input for High-Side U Phase
10	$V_{DD(H)}$	High-Side Common Bias Voltage for IC and IGBT Driving
11	$V_{B(U)}$	High-Side Bias Voltage for U Phase IGBT Driving
12	$V_{S(U)}$	High-Side Bias Voltage Ground for U Phase IGBT Driving
13	$IN_{(VH)}$	Signal Input for High-Side V Phase
14	$V_{DD(H)}$	High-Side Common Bias Voltage for IC and IGBT Driving
15	$V_{B(V)}$	High-Side Bias Voltage for V Phase IGBT Driving
16	$V_{S(V)}$	High-Side Bias Voltage Ground for V Phase IGBT Driving
17	$IN_{(WH)}$	Signal Input for High-Side W Phase
18	$V_{DD(H)}$	High-Side Common Bias Voltage for IC and IGBT Driving
19	$V_{B(W)}$	High-Side Bias Voltage for W Phase IGBT Driving
20	$V_{S(W)}$	High-Side Bias Voltage Ground for W Phase IGBT Driving
21	$N_U$	Negative DC Link Input for U Phase
22	$N_V$	Negative DC Link Input for V Phase
23	$N_W$	Negative DC Link Input for W Phase
24	U	Output for U Phase
25	V	Output for V Phase
26	W	Output for W Phase
27	P	Positive DC Link Input

### 3.3. Detailed Pin Definition and Notification

**Pins:**  $V_{B(U)}-V_{S(U)}$ ,  $V_{B(V)}-V_{S(V)}$ ,  $V_{B(W)}-V_{S(W)}$

- High-side bias voltage pins for driving the IGBT / high-side bias voltage ground pins for driving the IGBTs.
- These are drive power supply pins for providing gate drive power to the high-side IGBTs.
- The virtue of the ability to bootstrap the circuit scheme is that no external power supplies are required for the high-side IGBTs.
- Each bootstrap capacitor is charged from the  $V_{DD}$  supply during ON state of the corresponding low-side IGBT.
- To prevent malfunctions caused by noise and ripple in the supply voltage, a low-ESR, low-ESL filter capacitor should be mounted very close to these pins.
- Low-side bias voltage pin / high-side bias voltage pins.

**Pins:**  $V_{DD(L)}$ ,  $V_{DD(H)}$

- These are control supply pins for the built-in ICs.
- These four pins should be connected externally.
- To prevent malfunctions caused by noise and ripple in the supply voltage, a low-ESR, low-ESL filter capacitor should be mounted very close to these pins.
- Low-side common supply ground pins.

**Pin:** COM

- These are supply ground pins for the built-in ICs.
- Important! To avoid noise influences, the main power circuit current should not be allowed to flow through this pin.
- Bootstrap diode cathode pins.

**Pins:**  $V_{B(U)}$ ,  $V_{B(V)}$ ,  $V_{B(W)}$

- These are pins to connect internal bootstrap diode for each high-side bootstrapping.
- External resistor should be connected between these pins and each  $V_{DD(xH)}$ .
- Signal input pins.

**Pins:**  $IN_{(UL)}$ ,  $IN_{(VL)}$ ,  $IN_{(WL)}$ ,  $IN_{(UH)}$ ,  $IN_{(VH)}$ ,  $IN_{(WH)}$

- These pins control the operation of the built-in IGBTs.
- They are activated by voltage input signals. The terminals are internally connected to a Schmitt-trigger circuit composed of 5 V-class CMOS.
- The signal logic of these pins is active HIGH. The IGBT associated with each of these pins is turned ON when a sufficient logic voltage is applied to these pins.
- The wiring of each input should be as short as possible to protect the Motion SPM 3 against noise influences.
- To prevent signal oscillations, an RC coupling as illustrated in Figure 25 is recommended.
- Short-circuit and over-current detection input pin.

**Pin:**  $C_{SC}$

- The current sensing shunt resistor should be connected between the pin  $C_{SC}$  and the low-side ground COM to detect short-current.
- The shunt resistor should be selected to meet the detection levels matched for the specific application. An RC filter should be connected to the CSC pin to eliminate noise.
- The connection length between the shunt resistor and CSC pin should be minimized.
- Fault output pin.

**Pin: V<sub>FO</sub>**

- This is the fault output alarm pin. An active LOW output is given on this pin for a fault state condition in the SPM.
- The alarm conditions are: Short-Circuit Current Protection (SCP), and low-side bias Under-Voltage Lockout (UVLO).
- The VFO output is open drain configured. The VFO signal line should be pulled to the 5 V logic power supply with approximately 4.7 kΩ resistance.
- Analog Temperature Sensing Output Pin.

**Pin: V<sub>TS</sub>**

- This is to indicate the temperature of LVIC with analog voltage. LVIC itself creates some power loss, but mainly heat generated from the IGBTs will increase the temperature of the LVIC.
- VTS versus temperature characteristics is illustrated in Figure 15.
- Positive DC-link pin.

**Pin: P**

- This is the DC-link positive power supply pin of the inverter.
- It is internally connected to the collectors of the high-side IGBTs.
- To suppress surge voltage caused by the DC-link wiring or PCB pattern inductance, connect a smoothing filter capacitor close to this pin (tip: metal film capacitor is typically used).
- Negative DC-link pins.

**Pins: NU, NV, NW**

- These are the DC-link negative power supply pins (power ground) of the inverter.
- These pins are connected to the low-side IGBT emitters of the each phase.
- These pins are used to one shunt or three shunt resistor.
- Inverter power output pins.

**Pins: U, V, W**

- Inverter output pins for connecting to the inverter load (e.g. motor).

### 3.4. Package Structure

Since heat dissipation is an important factor limiting the power module's current capability, the heat dissipation characteristics of a package are important in determining the performance. A trade-off exists among heat dissipation characteristics, package size, and isolation characteristics. The key to good package technology lies in the optimization package size while maintaining outstanding heat dissipation characteristics without compromising the isolation rating.

In 600V SPM®3, technology was developed with DBC substrate that resulted in good heat dissipation characteristics. Power chips are attached directly to the DBC substrate. This technology is applied 600V SPM3, achieving improved reliability and heat dissipation.

Figure 4 shows the package outline and the cross-sections of the 600V SPM3 package.

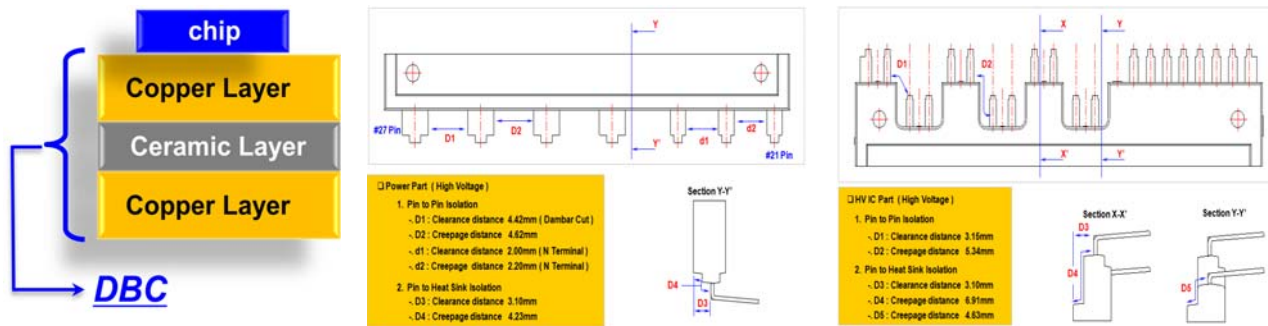


Figure 4. Vertical Structure for Heat Dissipation and Distance for Isolation

Figure 5 shows the internal package structure including the lead frame and bonding wires. This design has been revised several times to further improve the manufacturability and the reliability to please the customers more.

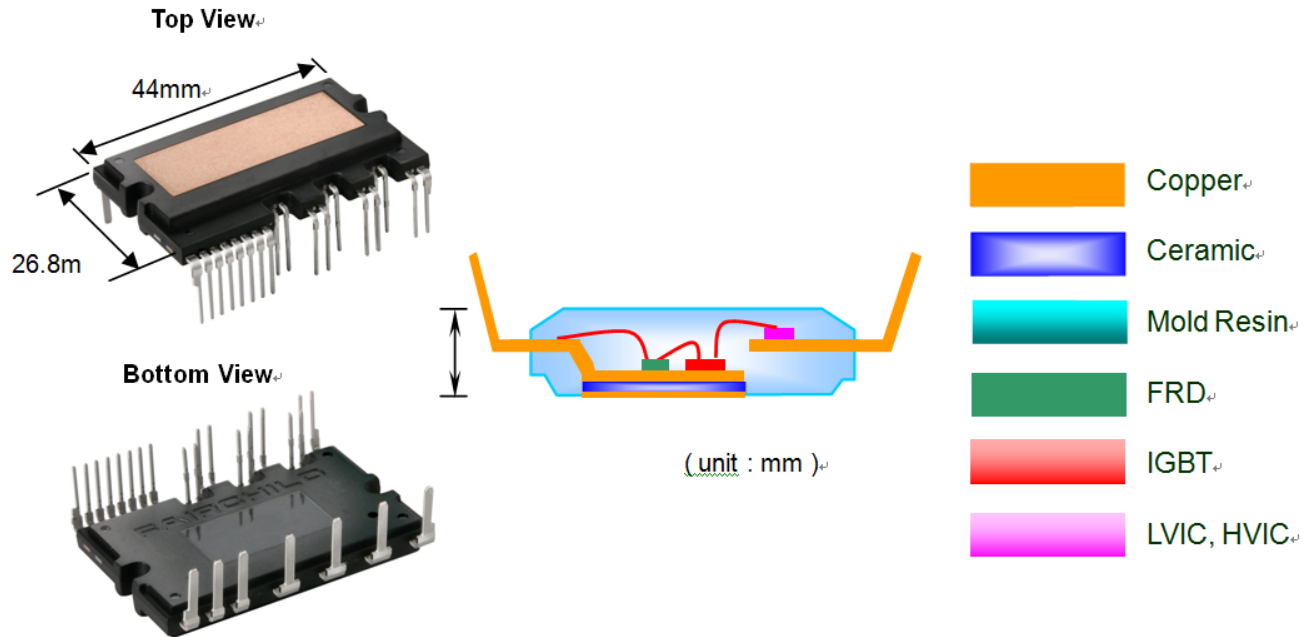
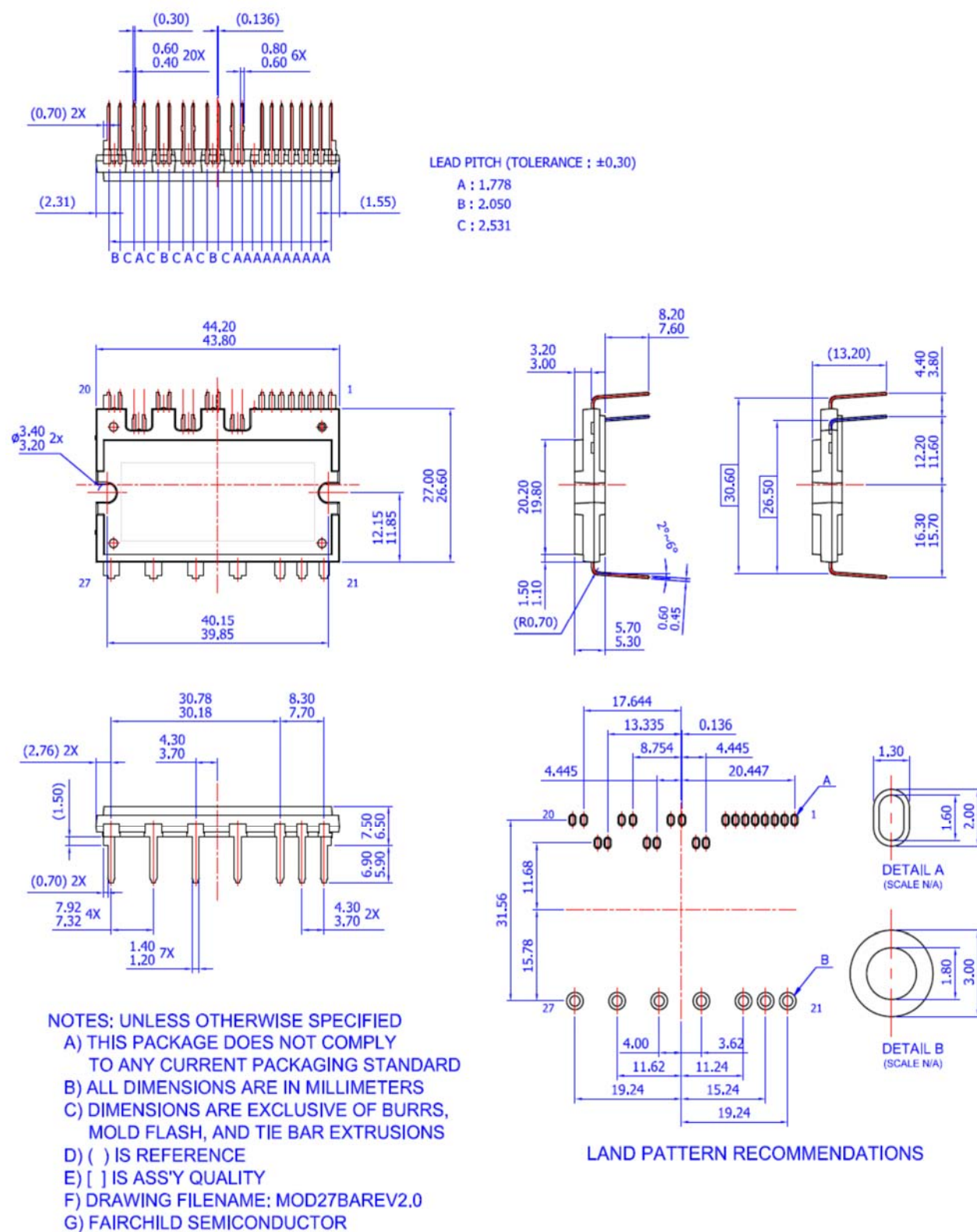


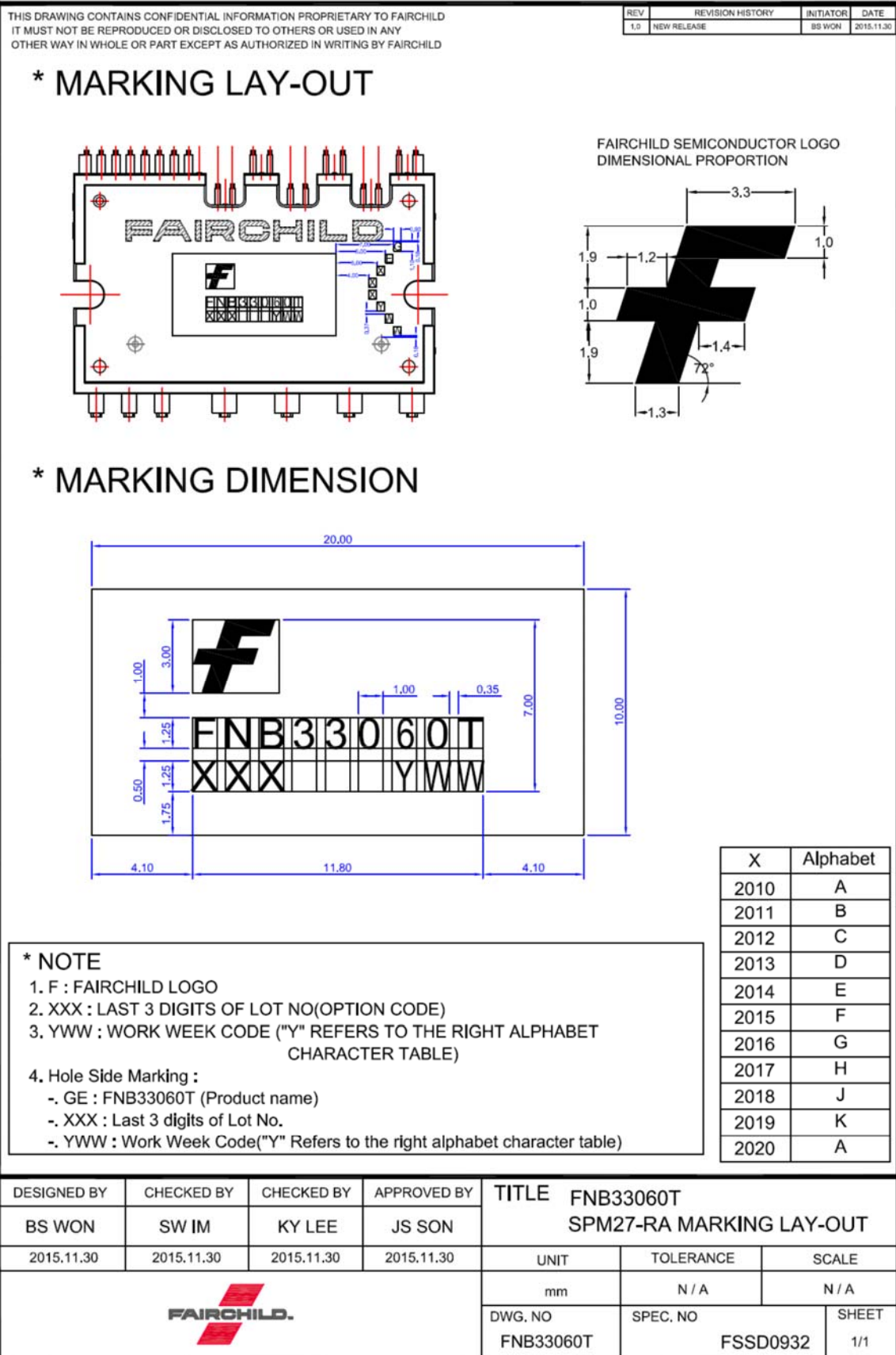
Figure 5. Package Structure and Cross Section for SPM27



### 3.5. Marking Specification



## 3.6. Marking Specification



## 4. Product Synopsis

This section discusses electrical specification, characteristics and mechanical characteristics.

### 4.1. Absolute Maximum Rating ( $T_J=25^{\circ}\text{C}$ , unless otherwise specified)

**Table 4. Inverter Part (Base on FNB33060T)**

Symbol	Parameter	Conditions	Rating	Unit
$V_{PN}$	Supply Voltage	Applied between P – NU, NV, NW	450	V
$V_{PN(\text{Surge})}$	Supply Voltage (Surge)	Applied between P – NU, NV, NW	500	V
$V_{CES}$	Collector – Emitter Voltage		600	V
$\pm I_C$	Each IGBT Collector Current	$T_C=25^{\circ}\text{C}$ , $T_J \leq 150^{\circ}\text{C}$ (Note 2)	30	A
$\pm I_{CP}$	Each IGBT Collector Current (Peak)	$T_C=25^{\circ}\text{C}$ , $T_J \leq 150^{\circ}\text{C}$ , Under 1 ms Pulse Width <sup>(2)</sup>	60	A
$P_C$	Collector Dissipation	$T_C=25^{\circ}\text{C}$ per One Chip	89	W
$T_J$	Operating Junction Temperature (Note 3)		-40~150	$^{\circ}\text{C}$

**Notes:**

2. These values had been made on acquisition by the calculation considered to design factor.
3. The maximum junction temperature rating of power chips integrated within the SPM3 version 6 products are  $150^{\circ}\text{C}$ .

**Table 5. Control Part**

Symbol	Parameter	Conditions	Rating	Unit
$V_{DD}$	Control Supply Voltage	Applied between $V_{DD(H)}$ , $V_{DD(L)}$ - COM	20	V
$V_{BS}$	High-Side Control Bias Voltage	Applied between $V_{B(U)}-V_{S(U)}$ , $V_{B(V)}-V_{S(V)}$ , $V_{B(W)}-V_{S(W)}$	20	V
$V_{IN}$	Input Signal Voltage	Applied between $IN_{(UH)}$ , $IN_{(VH)}$ , $IN_{(WH)}$ , $IN_{(UL)}$ , $IN_{(VL)}$ , $IN_{(WL)}$ , - COM	-0.3~ $V_{DD}+0.3$	V
$V_{FO}$	Fault Output Supply Voltage	Applied between $V_{FO}$ – COM	-0.3~ $V_{DD}+0.3$	V
$I_{FO}$	Fault Output Current	Sink Current at $V_{FO}$ Pin	2	mA
$V_{SC}$	Current Sensing Input Voltage	Applied between $C_{SC}$ - COM	-0.3~ $V_{DD}+0.3$	V

**Table 6. Bootstrap Diode Part**

Symbol	Parameter	Conditions	Rating	Unit
$V_{RRM}$	Maximum Repetitive Reverse Voltage		600	V
$I_F$	Forward Current	$T_C=25^{\circ}\text{C}$ , $T_J \leq 150^{\circ}\text{C}$	0.5	A
$I_{FP}$	Forward Current (Peak)	$T_C=25^{\circ}\text{C}$ , $T_J \leq 150^{\circ}\text{C}$ , Under 1 ms Pulse Width	2.0	A
$T_J$	Operating Junction Temperature		-40~150	$^{\circ}\text{C}$

**Table 7. Total System**

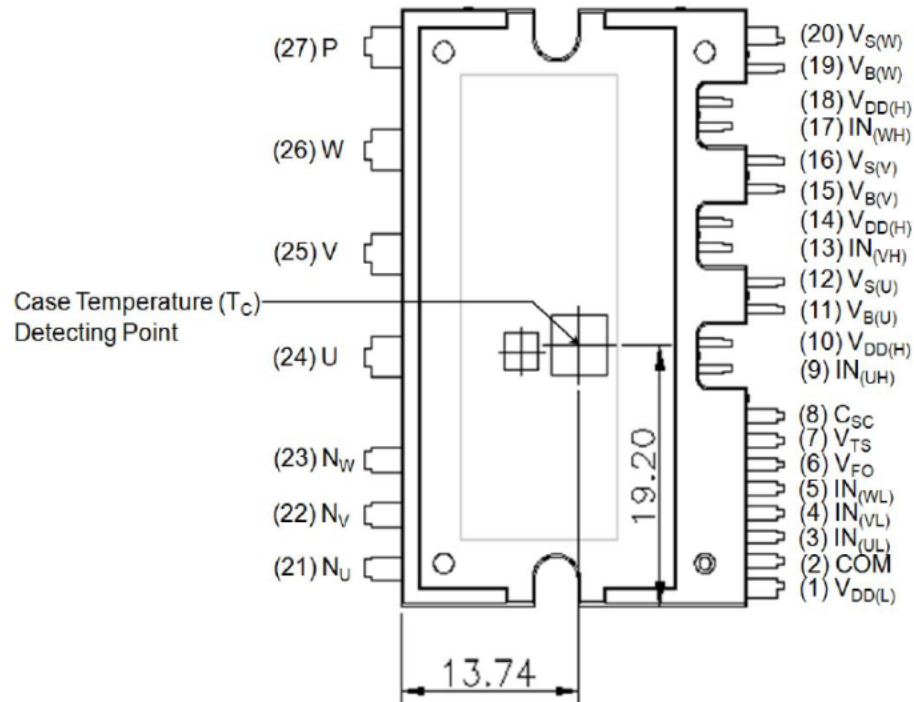
Symbol	Parameter	Conditions	Rating	Unit
$V_{PN(Prot)}$	Self Protection Supply Voltage Limit (Short-Circuit Protection Capability)	VDD, VBS=13.5~16.5 V, TJ=50°C, Non-Repetitive, < 2 $\mu$ s	400	V
$T_C$	Module Case Operation Temperature	See Figure 6Error! Reference source not found.	-40~125	°C
$T_{STG}$	Storage Temperature		-40~125	°C
$V_{ISO}$	Isolation Voltage	60 Hz, Sinusoidal, 1-Minute, Connect Pins to Heat Sink	2500	Vrms

**Table 8. Thermal Resistance**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-c)Q}$	Junction to Case Thermal Resistance (Note 4)	Inverter IGBT Part (per 1/6 Module)	1.4			°C/W
$R_{th(j-c)F}$		Inverter FWD Part (per 1/6 Module)	2.4			

**Note:**

4. For the measurement point of case temperature ( $T_C$ ), please refer Figure 6

**Figure 6. Case Temperature ( $T_C$ ) Detecting Point**

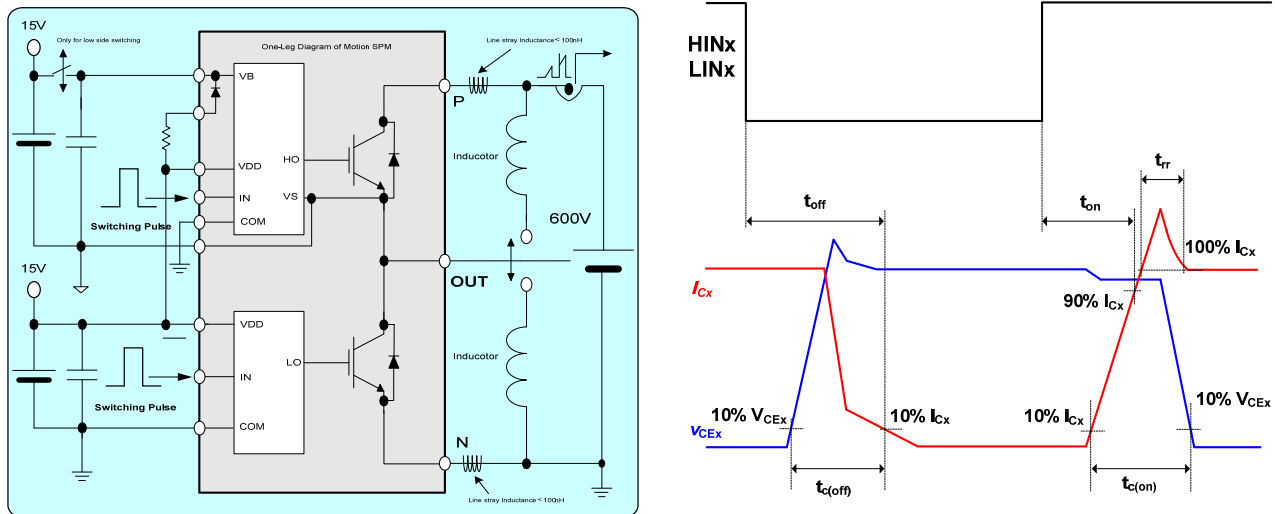
## 4.2. Electrical Characteristic ( $T_J=25^\circ\text{C}$ , unless otherwise specified)

**Table 9. Inverter Part (Base on FNB33060T)**

Symbol		Parameter	Condition		Min	Typ	Max	Unit
$V_{CE(SAT)}$		Collector–Emitter Saturation Voltage	$V_{DD}, V_{BS}=15\text{ V}$ , $V_{IN}=5\text{ V}$	$I_C=30\text{ A}$ , $T_J=25^\circ\text{C}$		1.60	2.20	V
$V_F$		FWD Forward Voltage	$V_{IN}=0\text{ V}$	$I_F=30\text{ A}$ , $T_J=25^\circ\text{C}$		2.00	2.60	V
HS	$t_{ON}$	Switching Times	$V_{PN}=300\text{ V}$ , $V_{DD}=15\text{ V}$ , $V_{BS}=15\text{ V}$ , $I_C=30\text{ A}$ $T_J=25^\circ\text{C}$ , $V_{IN}=0\text{ V} \leftrightarrow 5\text{ V}$ , Inductive Load See Figure 7		0.50	0.90	1.40	$\mu\text{s}$
	$t_{C(ON)}$					0.25	0.55	$\mu\text{s}$
	$t_{OFF}$					0.85	1.35	$\mu\text{s}$
	$t_{C(OFF)}$					0.15	0.40	$\mu\text{s}$
	$t_{rr}$					0.08		$\mu\text{s}$
LS	$t_{ON}$				0.40	0.80	1.30	$\mu\text{s}$
	$t_{C(ON)}$					0.25	0.55	$\mu\text{s}$
	$t_{OFF}$					0.90	1.40	$\mu\text{s}$
	$t_{C(OFF)}$					0.15	0.45	$\mu\text{s}$
	$t_{rr}$				0.10			$\mu\text{s}$
$I_{CES}$		Collector – Emitter Leakage Current	$V_{CE}=V_{CES}$				5	mA

**Note:**

5.  $t_{ON}$  and  $t_{OFF}$  include the propagation delay time of the internal drive IC.  $t_{C(ON)}$  and  $t_{C(OFF)}$  are the switching time of IGBT itself under the given gate driving condition internally. For the detail information, please see and Figure 7



**Figure 7. Switching Evaluation Circuit and Switching Time Definition**

**Table 10. Bootstrap Diode Part**

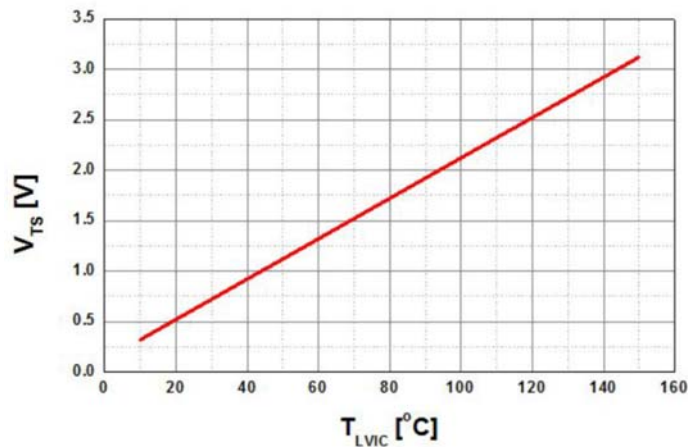
Symbol	Parameter	Condition	Min	Typ	Max	Unit
$V_F$	Forward Voltage	$I_F=0.1\text{ A}$ , $T_J=25^\circ\text{C}$		2.5		V
$t_{rr}$	Reverse Recovery Time	$I_F=0.1\text{ A}$ , $dI_F/dt=50\text{ A}/\mu\text{s}$ , $T_J=25^\circ\text{C}$		80		ns

Table 11. Control Part

Symbol	Parameter	Condition		Min	Typ	Max	Unit
$I_{QDDH}$	Quiescent $V_{DD}$ Supply Current	$V_{DD(H)}=15V, I_{N(UH,VH,WH)}=0V$	$V_{DD(H)} - COM$			0.50	mA
$I_{QDDL}$		$V_{DD(L)}=15V, I_{N(UL,VL,WL)}=0V$	$V_{DD(L)} - COM$			6.00	
$I_{PDDH}$	Operating High-Side $V_{DD}$ Supply Current	$V_{DD(H)}=15V, f_{PWM}=20\text{ kHz}, \text{Duty}=50\%$ , Applied to One PWM Signal Input for High Side				0.50	mA
$I_{PDDL}$		$V_{DD(L)}=15V, f_{PWM}=20\text{ kHz}, \text{Duty}=50\%$ , Applied to One PWM Signal Input for Low Side				10.0	
$I_{QBS}$	Quiescent $V_{BS}$ Supply Current	$V_{BS}=15V, I_{N(UH,VH,WH)}=0V$				0.30	mA
$I_{PBS}$	Operating $V_{BS}$ Supply Current	$V_{DD}=V_{BS}=15V, f_{PWM}=20\text{ kHz}, \text{Duty}=50\%$ , Applied to One PWM Signal Input for High Side				4.50	mA
$V_{FOH}$	Fault Output Voltage	$V_{DD}=15V, V_{SC}=0V, V_{FO}$ Circuit: 4.7 k $\Omega$ to 5 V Pull-up		4.5			V
$V_{FOL}$		$V_{DD}=15V, V_{SC}=1V, V_{FO}$ Circuit: 4.7 k $\Omega$ to 5 V Pull-up				0.5	
$V_{SC(ref)}$	Short-Circuit Trip Level	$V_{DD}=15V$	$C_{SC} - COM$	0.45	0.50	0.55	V
$UV_{DDD}$	Supply Circuit, Under-Voltage Protection (Note 6)	Detection Level		9.8		13.3	V
$UV_{DDR}$		Reset Level		10.3		13.8	
$UV_{BSD}$		Detection Level		9.0		12.5	
$UV_{BSR}$		Reset Level		9.5		13.0	
$t_{FOD}$	Fault-Out Pulse Width			50			$\mu s$
$V_{IN(ON)}$	ON Threshold Voltage	Applied between $I_{N(UH,VH,WH)} - COM, I_{N(UL,VL,WL)} - COM$				2.6	V
$V_{IN(OFF)}$	OFF Threshold Voltage			0.8			

**Note:**

6. Short-circuit current protection is functioning only at low side.

Figure 8. Temperature Profile of  $V_{TS}$  (Typical)

### 4.3. Recommended Operating Conditions

Symbol	Parameter	Condition	Min	Typ	Max	Unit
$V_{PN}$	Supply Voltage	Applied between P - $N_U$ , $N_V$ , $N_W$		300	400	V
$V_{DD}$	Control Supply Voltage	Applied between $V_{DD(UH,VH,WH)} - COM$ , $V_{DD(L)} - COM$	14.0	15.0	16.5	
$V_{BS}$	High-Side Bias Voltage	Applied between $V_{B(U)} - V_{S(U)}$ , $V_{B(V)} - V_{S(V)}$ , $V_{B(W)} - V_{S(W)}$	13.0	15.0	18.5	V
$dV_{DD}/dt$ , $dV_{BS}/dt$	Control Supply Variation		-1		+1	V/ $\mu$ s
$t_{dead}$	Blanking Time for Preventing Arm-Short	For Each Input Signal	1.0			$\mu$ s
$f_{PWM}$	PWM Input Signal	$-40^{\circ}C \leq T_C \leq 125^{\circ}C$ , $-40^{\circ}C \leq T_J \leq 150^{\circ}C$			20	kHz
$V_{SEN}$	Voltage for Current Sensing	Applied between $N_U$ , $N_V$ , $N_W - COM$ (Including Surge Voltage)	-5		5	V
$P_{WIN(ON)}$	Minimum Input Pulse Width	$V_{DD}=V_{BS}=15V$ , $I_C \leq 60A$ , Wiring Inductance between $N_{U,V,W}$ and DC Link $N < 10nH^{(7)}$	2.0			$\mu$ s
$P_{WIN(OFF)}$			2.0			
$T_J$	Junction Temperature		-40		150	$^{\circ}C$

**Note:**

7. This product might not make response if input pulse with is lee than the recommended value.

### 4.4. Mechanical Characteristics

Parameter	Condition		Min	Typ	Max	Unit
Device Flatness	See Figure 9	Error! Reference source not found.	0		+150	$\mu$ m
Mounting Torque	Mounting Screw: M3 See Figure 10	Recommended 0.7 N·m	0.6	0.7	0.8	N·m
		Recommended 7.1 kg·cm	6.2	7.1	8.1	kg·cm
Terminal Pulling Strength	Load 19.6 N		10			s
Terminal Bending Strength	Load 9.8 N, 90° Bend		2			Times
Weight	Module Weight			50		g

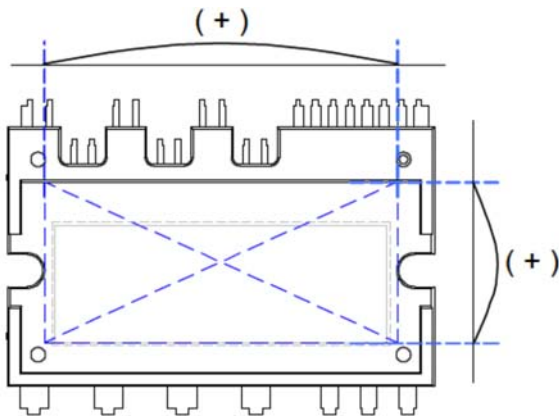


Figure 9. Flatness Measurements Position

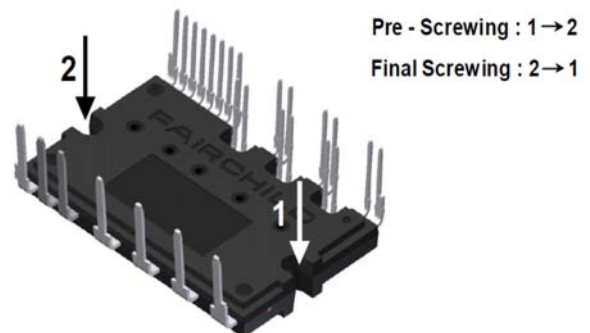


Figure 10. Mounting Screw Torque Order

## 5. Operation Sequence for Protections

### 5.1. Short Circuit Protection

The 600V SPM<sup>®</sup>3 uses external shunt resistor for the short circuit current detection, as shown in Figure 11. LVIC has a built-in short-circuit current protection function. This protection function senses the voltage to the CSC pin. If this voltage exceeds the  $V_{SC(ref)}$  (the threshold voltage trip level of the short-circuit) specified in the device datasheets ( $V_{SC(ref)}$ , typ. is 0.5 V), a fault signal is asserted and the all low side IGBTs are turned off.

Typically, the maximum short-circuit current magnitude is gate-voltage dependent: higher gate voltage ( $V_{DD}$  and  $V_{BS}$ ) results in larger short-circuit current. To avoid potential problems, the maximum short-circuit trip level is set below 1.5 times the nominal rated collector current. The LVIC short-circuit current protection-timing chart is shown in Figure 12.

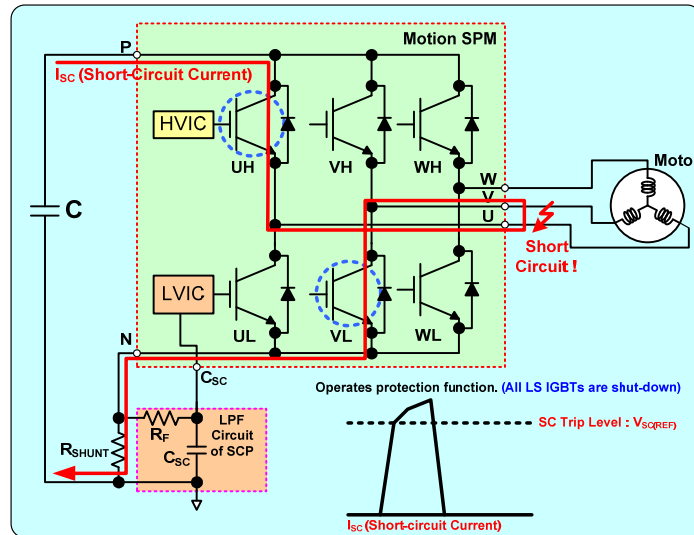


Figure 11. Operation of Short-Circuit Protection



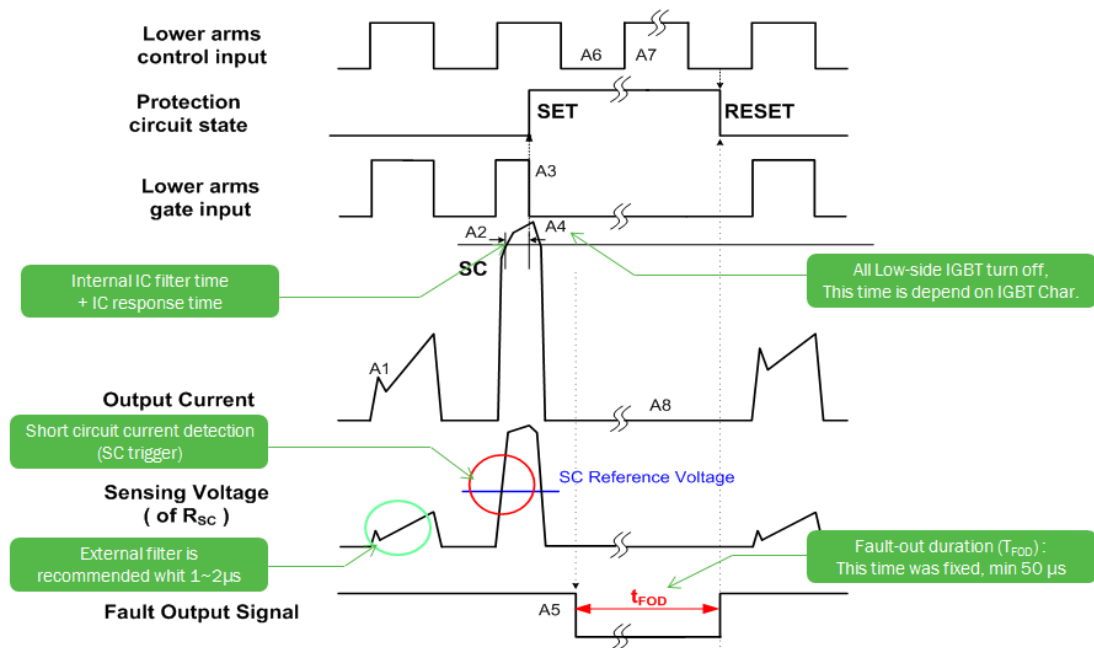


Figure 12. Timing Chart of Short-Circuit Protection Function

**Notes:**

8. A1-normal operation: IGBT on and carrying current.
9. A2-short-circuit current detection (SC trigger).
10. A3-hard IGBT gate interrupt.
11. A4-IGBT turns OFF.
12. A5-fault output timer operation start with internal delay (typ. 2.8 μs), Fault-out duration time is fix (min. 50 μs).
13. A6-input "L": IGBT OFF state.
14. A7-input "H": IGBT ON state, but during the active period of fault output the IGBT doesn't turn ON.
15. A8-IGBT keeps OFF state

**5.2. Under-Voltage Lockout Protection**

The LVIC has an Under-Voltage Lockout protection (UVLO) function to protect the low-side IGBTs from operation with insufficient gate driving voltage. A timing chart for this protection is shown in Figure 13

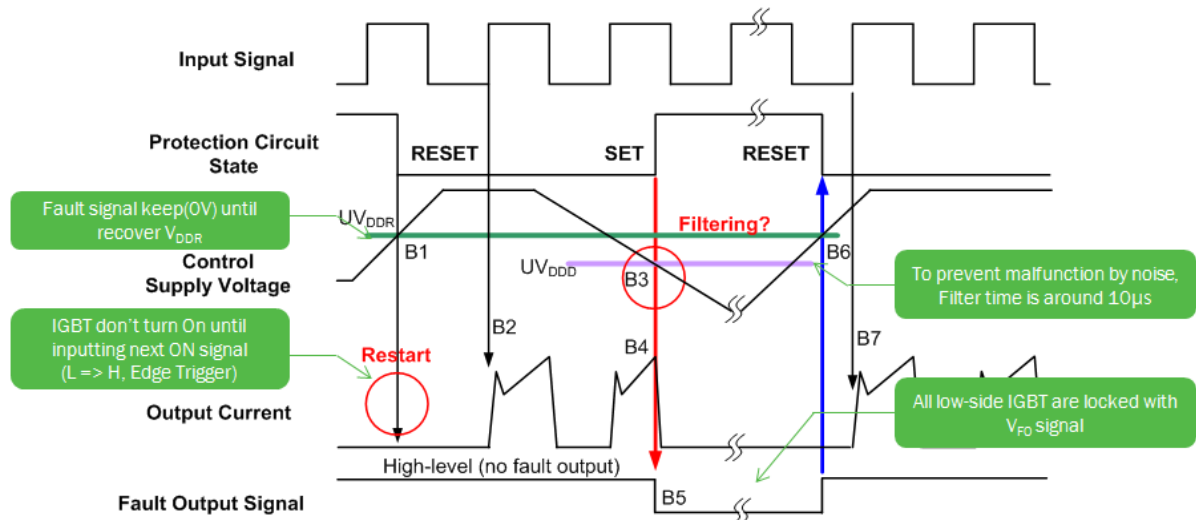


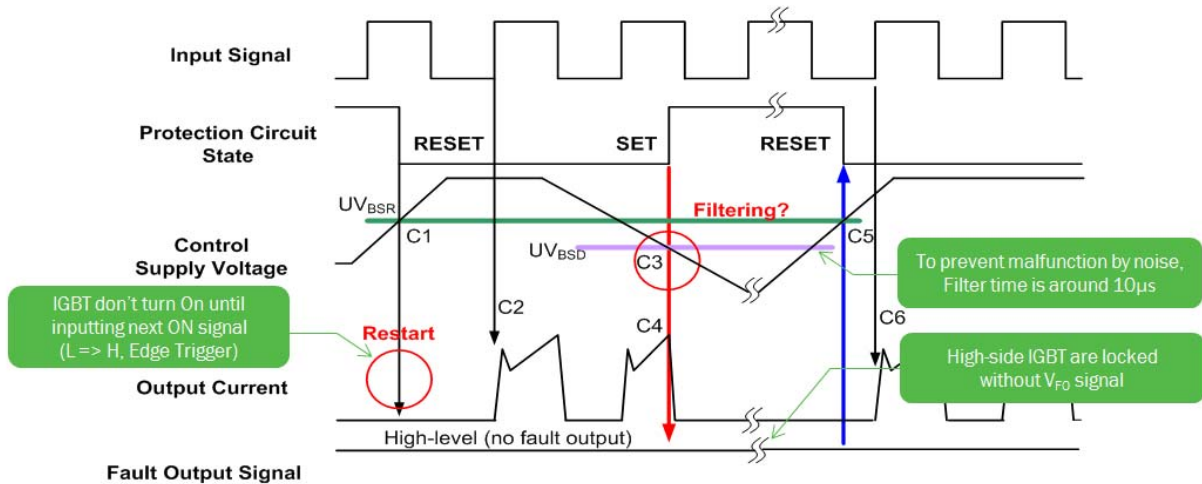
Figure 13. Timing Chart of Low-side Under-Voltage Protection Function

**Notes: (Low-Side Protection Sequence)**

16. B1-control supply voltage rise: after the voltage rises  $UV_{DDR}$ , the circuits starts to operate when the next input is applied (L => H)
17. B2-normal operation: IGBT ON and carrying current.
18. B3-under-voltage detection ( $UV_{DDD}$ ).
19. B4-IGBT OFF in spite of control input is alive.
20. B5-Fault output signal starts.
21. B6-under-voltage reset ( $UV_{DDR}$ ).
22. B7-normal operation: IGBT ON and carrying current

### 5.3. Under-Voltage Lockout Protection (High-side UVLO )

The HVIC has an under-voltage lockout function to protect the high-side IGBT from insufficient gate driving voltage. A timing chart for this protection is shown in Figure 14. A fault-out (FO) alarm is not given for low HVIC bias conditions



**Figure 14. Timing Chart of High-Side Under-Voltage Protection Function**

**Notes:** (High-Side Protection Sequence)

23. C1-control supply voltage rises: after the voltage reaches UV<sub>BSR</sub>, the circuit starts when the next input is applied.
24. C2-normal operation: IGBT ON and carrying current.
25. C3-under-voltage detection (UV<sub>BSD</sub>).
26. C4-IGBT OFF in spite of control input is alive, but there is no fault output signal.
27. C5-under-voltage reset (UV<sub>BSR</sub>).
28. C6-normal operation: IGBT ON and carrying current

## 6. Key Parameter Design Guidance

For stable operation, there are recommended parameters for passive components and bias conditions, considering operating characteristics of the 600V SPM®3 version 6 series

### 6.1. Thermal Sensing Unit (TSU)

The junction temperature of power devices should not exceed the maximum junction temperature. Even though there is some margin between the  $T_{JMAX}$  specified on the datasheet and the actual  $T_{JMAX}$  at which power devices get destroyed, caution should be given to make sure the junction temperature stays well below the  $T_{JMAX}$ . One of the inconveniences in using previous versions of SPM 3 series products was lack of temperature monitoring. An NTC had to be mounted on the heat sink or very close to the module if over-temperature protection is required in the application

#### 6.1.1. Basic Concept

Thermal Sensing Unit uses technology based on the temperature dependency of transistor Vbe; Vbe decrease 2 mV as temperature increase 1°C.

The Thermal Sensing Unit analog voltage output reflects the temperature of the LVIC in 600V SPM 3 version 6 series products. The relationship between  $V_{TS}$  voltage output and LVIC temperature is shown in Figure 16. It does not have any self-protection function, and, therefore, it should be used appropriately based on application requirement. It should be noted that there is a time lag from IGBT temperature to LVIC temperature. It is very difficult to respond quickly when temperature rises sharply in a transient condition such as shoot-through event. Even though TSU has some limitation, it will be definitely useful in enhancing the system reliability.

Figure 15 shows the LVIC location of SPM3 series.

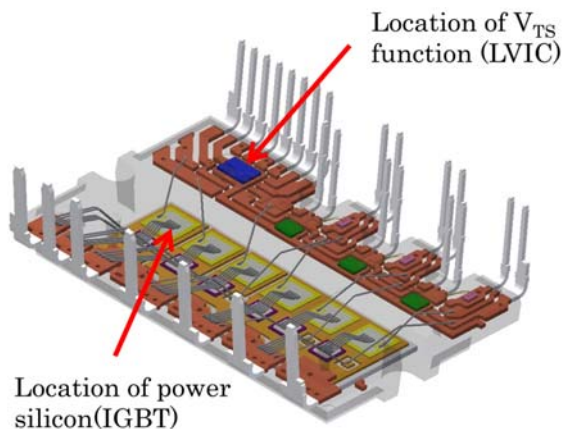


Figure 15. Location of VTS Function (LVIC)

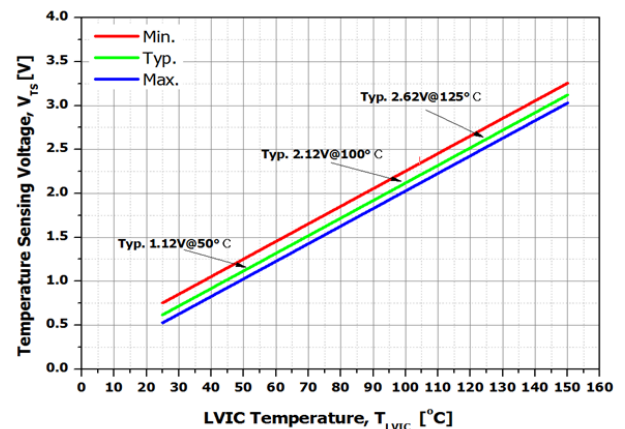
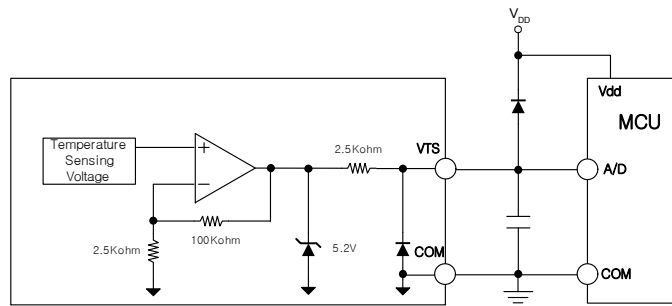


Figure 16. Temperature vs.  $V_{TS}$

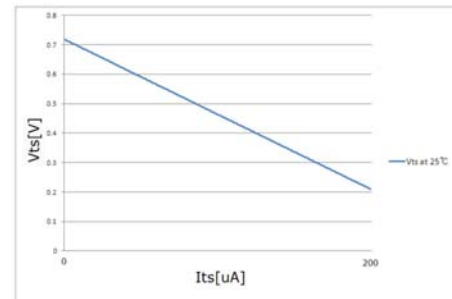
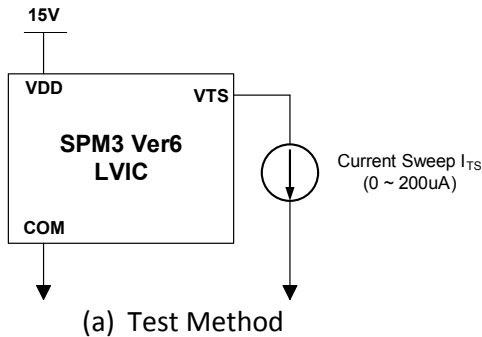
**Error! Reference source not found.** shows the equivalent circuit diagram of TSU inside IC and a typical application diagram. This output voltage is clamped to 5.2 V by an internal Zener diode, but in case the maximum input range of Analog to Digital converter of MCU is below 5.2 V, an external Zener diode should be inserted between an A/D input pin and the analog ground pin of MCU. An amplifier can be used to change the range of voltage input to the Analog to Digital converter to have better resolution of the temperature. It is recommended to add a ceramic capacitor of 1000 pF between  $V_{TS}$  and Com (Ground) to make the  $V_{TS}$  more stable.



**Figure 17. Internal Block Diagram and Interface Circuit of TSU**

Figure 18 shows the sourcing capability of  $V_{TS}$  pin at 25°C and the test method.  $V_{TS}$  voltage decreases as the sourcing current increases. Therefore, the load connected to  $V_{TS}$  pin should be minimized to maintain the accurate voltage output level without degradation. Figure 16Figure 16 shows that the relationship between  $V_{TS}$  voltage and LVIC temperature. It can be expressed as the following equation.

- $V_{TS,min} = 0.02 * T_{LVIC} + 0.04$  [V]
- $V_{TS,typ} = 0.02 * T_{LVIC} + 0.14$  [V]
- $V_{TS,max} = 0.02 * T_{LVIC} + 0.24$  [V]



(B) Test Result

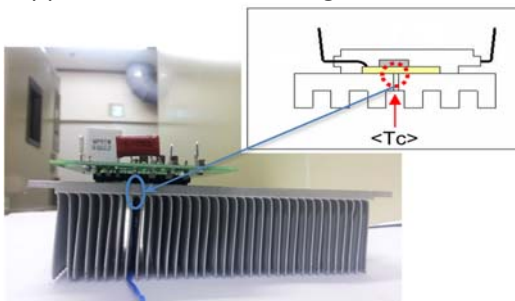
**Figure 18. Real Load Variation of VTS**

The maximum variation of  $V_{TS}$  is 0.24 V, and the minimum variation of  $V_{TS}$  is 0.04 V due to process variation which is equivalent  $\pm 5^\circ\text{C}$  approximately. This is regardless of the temperature because the slopes of three lines are identical. If the ambient temperature information is available, for example, through NTC in the system,  $V_{TS}$  can be measured to adjust the offset before the motor starts to operate.

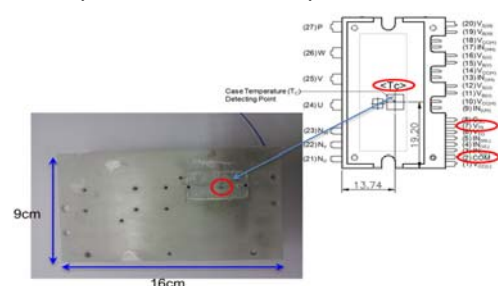
As temperature decreases further below  $0^\circ\text{C}$ ,  $V_{TS}$  decreases linearly until it reaches zero volts. If the temperature of LVIC increases above  $150^\circ\text{C}$ , which is above the maximum operating temperature,  $V_{TS}$  would increase theoretically up to 5.2 V until it gets clamped by the internal Zener diode.

### 6.1.2. Test Method

This test result shows correlation between  $V_{TS}$  and  $T_C$ , but this correlation will be changed each customer real application conditions. Figure 19 shows the test board and temperature measure point.



(a) Test board



(B) Heat-sink Size and Measure Point of  $T_C$

**Figure 19. Heat-sink size and measure point of  $T_C$**

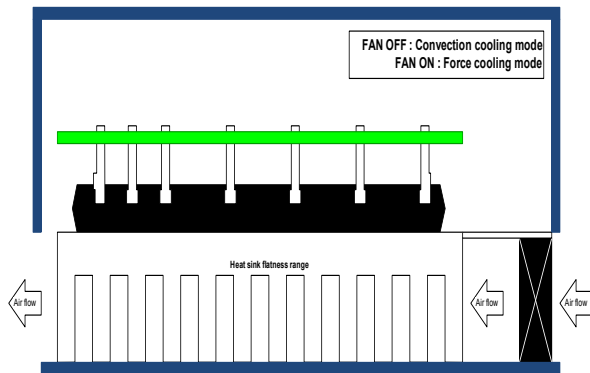
We tested real load by servo dynamo systems, refer to the Figure 20.

**Figure 20. Real Load Dynamometer**

We have compared between convection cooling and forced cooling mode. Figure 21 shows the cooling conditions

To avoid external environment, we used the case, refer to Figure 22.

Test conditions were  $V_{DD} = 15\text{ V}$ ,  $V_{DC} = 300\text{ V}$ , Frequency = 5 kHz and PWM method=SPWM.

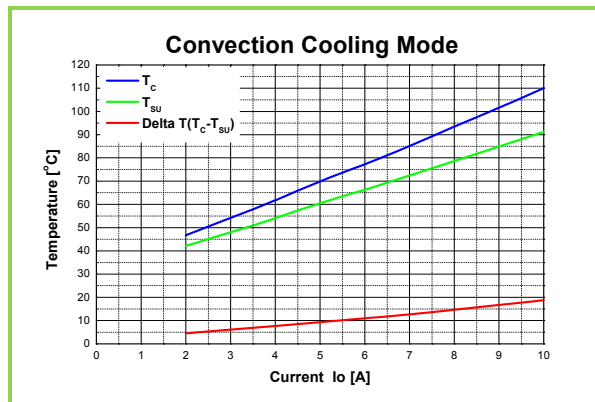


**Figure 21. Cooling Conditions**

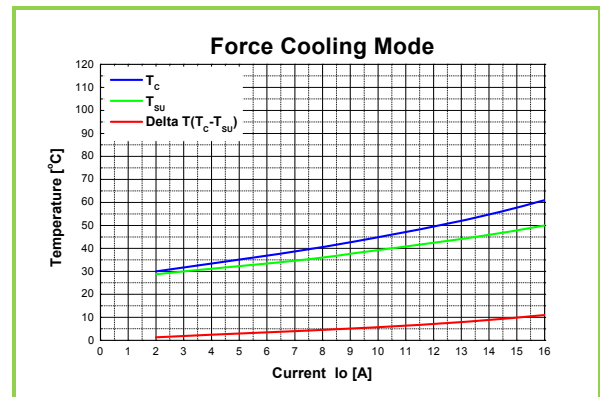
**Figure 22. Test Environment**

### 6.1.3. Test Results

Figure 23 and Figure 24 shows the test result. As the test results,  $T_C$  and  $V_{TS}$  temperatures have a variable gap by cooling conditions. Fragmentarily, this test result shows,  $V_{TS}$  value is depend on cooling conditions (Heat sink size, Fan speed and etc). Temperature gap has about 20 degree between  $T_C$  and  $V_{TS}$  in convection cooling mode. And gap has about 10 degree in force cooling mode.



**Figure 23. Convection Cooling Mode**



**Figure 24. Force Cooling Mode**

In conclusion, if the customer wants to use the thermal sensing unit ( $T_{SU}$ ), they should make adjustment in real operation conditions by themselves. And heat generated at IGBT and FWDi transfer to LVIC through modeling resin of package and outer heat sink. So LVIC temperature cannot respond to rapid temperature rise of those power chips effectively.

**Table 12.  $V_{TS}$  Table of LVIC**

$T_{LVIC}$ (°C)	$V_{MIN}$ (V)	$V_{TYP}$ (V)	$V_{MAX}$ (V)	$T_{LVIC}$ (°C)	$V_{MIN}$ (V)	$V_{TYP}$ (V)	$V_{MAX}$ (V)
25	0.54	0.64	0.74	70	1.44	1.54	1.64
26	0.56	0.66	0.76	71	1.46	1.56	1.66
27	0.58	0.68	0.78	72	1.48	1.58	1.68
28	0.60	0.70	0.80	73	1.50	1.60	1.70
29	0.62	0.72	0.82	74	1.52	1.62	1.72
30	0.64	0.74	0.84	75	1.54	1.64	1.74
31	0.66	0.76	0.86	76	1.56	1.66	1.76
32	0.68	0.78	0.88	77	1.58	1.68	1.78
33	0.70	0.80	0.90	78	1.60	1.70	1.80
34	0.72	0.82	0.92	79	1.62	1.72	1.82
35	0.74	0.84	0.94	80	1.64	1.74	1.84
36	0.76	0.86	0.96	81	1.66	1.76	1.86
37	0.78	0.88	0.98	82	1.68	1.78	1.88
38	0.80	0.90	1.00	83	1.70	1.80	1.90
39	0.82	0.92	1.02	84	1.72	1.82	1.92
40	0.84	0.94	1.04	85	1.74	1.84	1.94
41	0.86	0.96	1.06	86	1.76	1.86	1.96
42	0.88	0.98	1.08	87	1.78	1.88	1.98
43	0.90	1.00	1.10	88	1.80	1.90	2.00
44	0.92	1.02	1.12	89	1.82	1.92	2.02
45	0.94	1.04	1.14	90	1.84	1.94	2.04
46	0.96	1.06	1.16	91	1.86	1.96	2.06
47	0.98	1.08	1.18	92	1.88	1.98	2.08
48	1.00	1.10	1.20	93	1.90	2.00	2.10
49	1.02	1.12	1.22	94	1.92	2.02	2.12
50	1.04	1.14	1.24	95	1.94	2.04	2.14
51	1.06	1.16	1.26	96	1.96	2.06	2.16
52	1.08	1.18	1.28	97	1.98	2.08	2.18
53	1.10	1.20	1.30	98	2.00	2.10	2.20
54	1.12	1.22	1.32	99	2.02	2.12	2.22
55	1.14	1.24	1.34	100	2.04	2.14	2.24
56	1.16	1.26	1.36	101	2.06	2.16	2.26
57	1.18	1.28	1.38	102	2.08	2.18	2.28
58	1.20	1.30	1.40	103	2.10	2.20	2.30
59	1.22	1.32	1.42	104	2.12	2.22	2.32
60	1.24	1.34	1.44	105	2.14	2.24	2.34
61	1.26	1.36	1.46	106	2.16	2.26	2.36
62	1.28	1.38	1.48	107	2.18	2.28	2.38
63	1.30	1.40	1.50	108	2.20	2.30	2.40
64	1.32	1.42	1.52	109	2.22	2.32	2.42
65	1.34	1.44	1.54	110	2.24	2.34	2.44
66	1.36	1.46	1.56	111	2.26	2.36	2.46
67	1.38	1.48	1.58	112	2.28	2.38	2.48
68	1.4	1.5	1.6	113	2.30	2.40	2.50
69	1.42	1.52	1.62	114	2.32	2.42	2.52





Where:

$$V_{O,LL} = \frac{\sqrt{3}}{\sqrt{2}} \times MI \times \frac{V_{DC}}{2}$$

$I_{(O)RMS}$  = Maximum load current of inverter; and

MI = Modulation Index;

VDC = DC link voltage;

PF = Power Factor

- Average DC Current

$$I_{DC\_AVG} = V_{DC\_Link} / (P_{out} \times Eff)$$

Where:

Eff = Inverter Efficiency

- The power rating of shunt resistor is calculated by the following equation.

$$P_{SHUNT} = (I_{RMS}^2 \times R_{SHUNT} \times Margin) / \text{De-rating Ratio}$$

Where:

Shunt resistor typical value at  $T_C = 25^\circ\text{C}$  ( $R_{SHUNT}$ )

De-rating ratio of shunt resistor at  $T_{SHUNT} = 100^\circ\text{C}$  (From datasheet of shunt resistor)

Safety margin (Determine by customer)

### 6.2.2. The value of shunt Resistor calculation Examples:

- DUT: FNB33060T
- Tolerance of shunt resistor:  $\pm 5\%$
- SC Trip Reference Voltage:
- $V_{SC(min)} = 0.45\text{ V}$ ,  $V_{SC(typ)} = 0.50\text{ V}$ ,  $V_{SC(max)} = 0.55\text{ V}$
- Maximum Load Current of Inverter ( $I_{RMS}$ ):  $21\text{ A}_{rms}$
- Maximum Peak Load Current of Inverter ( $I_{C(max)}$ ):  $45\text{ A}$
- Modulation Index(MI): 0.9
- DC Link Voltage( $V_{DC\_Link}$ ):  $300\text{ V}$
- Power Factor (PF): 0.8
- Inverter Efficiency(Eff): 0.95
- Shunt Resistor Value at  $T_C = 25^\circ\text{C}$  ( $R_{SHUNT}$ ):  $11.0\text{ m}\Omega$
- De-rating Ration of Shunt Resistor at  $T_{SHUNT} = 100^\circ\text{C}$ : 70% (refer to Figure 26)
- Safety Margin: 20%

### 6.2.3. Calculation Results:

- $I_{SC(max)}: 1.5 \times I_{C(max)} = 1.5 \times 30\text{ A} = 45\text{ A}$
- $R_{SHUNT(typ)}: V_{SC(typ)} / I_{SC(max)} = 0.50\text{ V} / 45\text{ A} = 11.0\text{ m}\Omega$
- $R_{SHUNT(max)}: R_{SHUNT(typ)} \times 1.05 = 11\text{ m}\Omega \times 1.05 = 11.55\text{ m}\Omega$
- $R_{SHUNT(min)}: R_{SHUNT(typ)} \times 0.95 = 11\text{ m}\Omega \times 0.95 = 10.45\text{ m}\Omega$
- $I_{SC(min)}: V_{SC(min)} / R_{SHUNT(max)} = 0.45\text{ V} / 11.55\text{ m}\Omega = 38.96\text{ A}$
- $I_{SC(max)}: V_{SC(typ)} / R_{SHUNT(min)} = 0.55\text{ V} / 10.45\text{ m}\Omega = 52.6\text{ A}$
- $P_{OUT} = \sqrt{3} \times \left( \frac{\sqrt{3}}{\sqrt{2}} \times MI \times \frac{V_{DC}}{2} \right) \times I_{(O)RMS} \times PF = \frac{3}{\sqrt{2}} \times 0.9 \times (300/2) \times 21 \times 0.8 = 4,811\text{ W}$
- $I_{DC\_AVG} = (P_{OUT}/Eff) / V_{DC\_Link} = 16.88\text{ A}$
- $P_{SHUNT} = (I_{DC\_AVG}^2 \times R_{SHUNT} \times Margin) / \text{De-rating Ratio} = (16.88^2 \times 0.012 \times 1.2) / 0.7 = 5.86\text{ W}$   
(therefore, the proper power rating of shunt resistor is over  $6.0\text{ W}$ ).

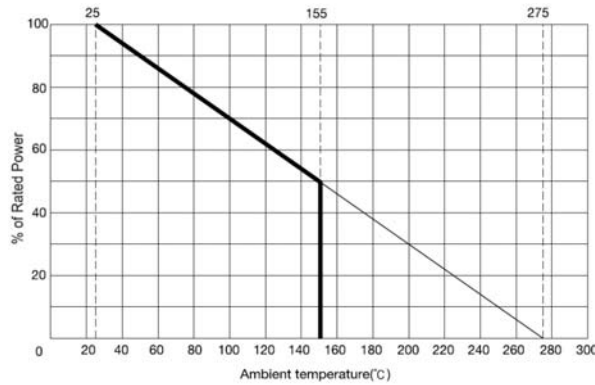
When over-current events are detected, the 600 V Motion SPM®3 version 6 series shuts down all low-side IGBTs and sends out the fault-out ( $F_O$ ) signal. Fault-out pulse width is fixed; minimum value is  $50\text{ }\mu\text{s}$ .

To prevent malfunction, it is recommended that an RC filter be inserted at the  $C_{SC}$  pin. To shut down IGBTs within  $3\text{ }\mu\text{s}$  when over-current situation occurs, a time constant of  $1.5 \sim 2\text{ }\mu\text{s}$  is recommended.

Table 13 shows the shunt resistance and typical short-circuit protection current

**Table 13. Over-Current(OC) Protection Trip Level**

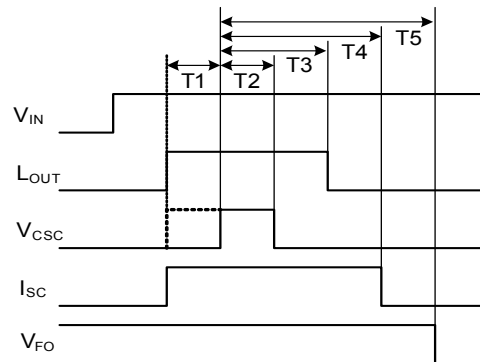
Device	R <sub>SHUNT</sub>	OC Trip Level	Remark
FNB33060T	11 mΩ	45 A	It is typical value
FNB34060T	8.3 mΩ	60 A	
FNB35060T	6.7 mΩ	75 A	

**Figure 26. De-rating Curve Example of Shunt Resistor (from RARA Elec.)**

### 6.3. Time Constant of Internal Delay

An RC filter is prevents noise-related Short-Circuit Current Protection (SCP) circuit malfunction. The RC time constant is determined by the applied noise time and the Short-Circuit Current Withstanding Time (SCWT) of SPM3 version6 series.

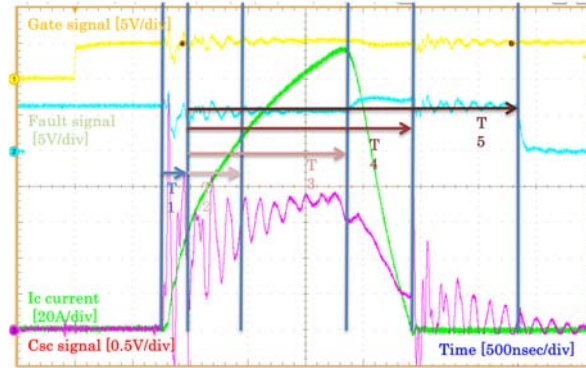
When the  $R_{SC}$  voltage exceeds the SCP level, this is applied to the CSC pin via the RC filter. The RC filter delay (T1) is the time required for the CSC pin voltage to rise to the referenced SCP level. The LVIC has an internal filter time (logic filter time for noise elimination: T2, around 0.7  $\mu$ s). Consider this filter time when designing the RC filter of  $V_{CSC}$

**Figure 27. Timing Diagram**

Notes:

29.  $V_{IN}$ : Voltage of input signal.
30.  $L_{OUT}$ : VGE of low-side IGBT.
31.  $V_{CSC}$ : Voltage of CSC pin.
32.  $I_{SC}$ : Short-circuit current.
33.  $V_{FO}$ : Voltage of VFO pin.
34. T1: filtering time of RC filter of  $V_{CSC}$ .
35. T2: filtering time of CSC. If  $V_{CSC}$  width is less than T2, SCP does not operate.
36. T3: delay from CSC triggering to gate-voltage down.
37. T4: delay from CSC triggering to short-circuit current.
38. T5: delay from CSC triggering to fault-out signal.

Figure 28 shows operating waveform of SCP (Short-circuit Current Protection) function. Normally,  $\tau$  (time constant of RC filter of  $C_{SC}$ ) don't accurately operate due to fast  $di/dt$  of  $I_{SC}$  (short-circuit current). Therefore, we should consider this kind of situation when decide time constant of RC filter of  $C_{SC}$ . (Normally,  $\tau$  (time constant of RC filter of  $C_{SC}$ ) accurately operates in Over-Current Protection operation (OCP).



**Figure 28. Short Circuit Waveform (FNB33060T, Ref. Condition:  $V_{DD}=16.5\text{ V}$ ,  $V_{DC}=400\text{ V}$ ,  $T_J=25^\circ\text{C}$ )**

Table 14 shows actual real time at short circuit current protection. Each time sections have a distribution, so we have to consider of distribution

**Table 14. Time Table on Short Circuit Conditions;  $V_{CSC}$  to  $L_{OUT}$ ,  $I_{SC}$ ,  $V_{FO}$**

Device	Typ. at $T_J=25^\circ\text{C}$	Typ. at $T_J=150^\circ\text{C}$	Max. at $T_J=25^\circ\text{C}$
FNB33060T	$T2=0.80\mu\text{s}$	$T2=0.52\mu\text{s}$	Considering $\pm 20\%$ Distribution, T3 and T4
	$T3=1.35\mu\text{s}$	$T3=1.23\mu\text{s}$	
	$T4=1.95\mu\text{s}$	$T4=1.81\mu\text{s}$	
	$T5=2.86\mu\text{s}$	$T5=2.47\mu\text{s}$	

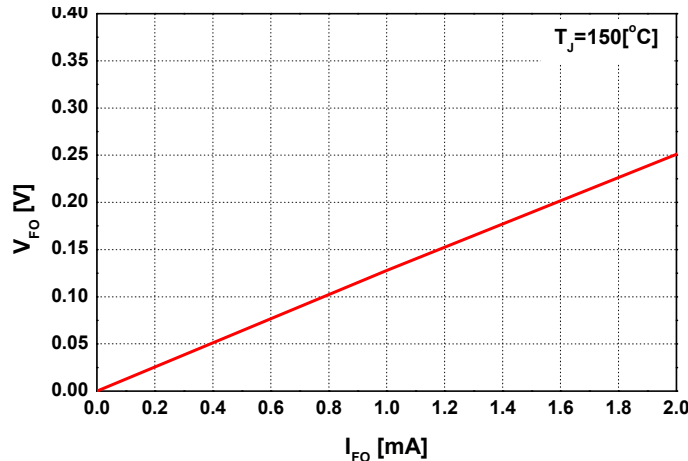
**Notes:**

39. To guarantee safe short-circuit protection under all operating conditions, CSC should be triggered within  $1.0\mu\text{s}$  after short-circuit occurs. (Recommendation:  $SCWT < 3.0\mu\text{s}$ , Conditions:  $V_{DC}=400\text{V}$ ,  $V_{DD}=16.5\text{ V}$ ,  $T_J=150^\circ\text{C}$ ).

40. It is recommended that delay from short-circuit to  $C_{SC}$  triggering should be minimized.

#### 6.4. Fault Output Circuit

Because  $V_{FO}$  terminal is an open-drain type; it should be pulled up via a pull-up resistor. The resistor must satisfy the above specifications.



**Figure 29. Voltage-Current Characteristics of  $V_{FO}$  Terminal**

## 6.5. Bootstrap Circuit Design

### 6.5.1. Operation of Bootstrap Circuit

The  $V_{BS}$  voltage, which is the voltage difference between  $V_{B(U,V,W)}$  and  $V_{S(U,V,W)}$ , provides the supply to the HVIC within the 600V SPM<sup>®</sup>3 series. This supply must be in the range of 13.0 V~18.5 V to ensure that the HVIC can fully drive the high-side IGBT. The SPM3 series includes an under-voltage lock out protection function for the  $V_{BS}$  to ensure that the HVIC does not drive the high-side IGBT, if the  $V_{BS}$  voltage drops below a specified voltage. This function prevents the IGBT from operating in a high dissipation mode. There are a number of ways in which the  $V_{BS}$  floating supply can be generated. One of them is the bootstrap method described here (refer to Figure 30). This method has the advantage of being simple and inexpensive. However, the duty cycle and on-time are limited by the requirement to refresh the charge in the bootstrap capacitor. The bootstrap to ground (either through the low-side or the load), the bootstrap capacitor ( $C_{BS}$ ) is charged through the bootstrap diode ( $D_{BS}$ ) and the resistor ( $R_{BS}$ ) from the  $V_{DD}$  supply

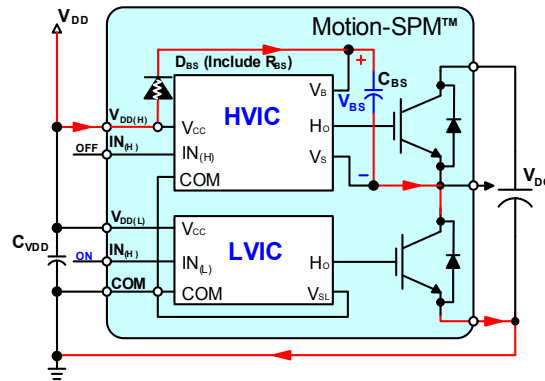


Figure 30. Current Path of Bootstrap Circuit

### 6.5.2. Selection of Bootstrap Capacitor Considering Initial Charging

Adequate on-time of the low-side IGBT to fully charge the bootstrap capacitor is required for initial bootstrap charging. The initial charging time ( $t_{charge}$ ) can be calculated by:

$$t_{charge} = C_{BS} \times R_{BS} \times \frac{1}{\Delta} \times \ln \frac{V_{DD}}{V_{DD} - V_{BS(min)} - V_F - V_{LS}} \quad (1)$$

Where:

$V_F$  = Forward voltage drop across the bootstrap diode;

$V_{BS(min)}$  = The minimum value of the bootstrap capacitor;

$V_{LS}$  = Voltage drop across the low-side IGBT or load; and

$\Delta$  = Duty ratio of PWM.

When the bootstrap capacitor is charged initially;  $V_{DD}$  drop voltage is generated based on initial charging method,  $V_{DD}$  line SMPS output current,  $V_{DD}$  source capacitance, and bootstrap capacitance. If  $V_{DD}$  drop voltage reaches  $UV_{DD}$  level, the low side is shut down and a fault signal is activated.

To avoid this malfunction, related parameter and initial charging method should be considered. To reduce  $V_{DD}$  voltage drop at initial charging, a large  $V_{DD}$  source capacitor and selection of optimized low-side turn-on method are recommended. Adequate on-time duration of the low-side IGBT to fully charge the bootstrap capacitor is initially required before normal operation of PWM starts.

Figure 31 shows an example of initial bootstrap charging sequence. Once  $V_{DD}$  establishes,  $V_{BS}$  needs to be charged by turning on the low-side IGBTs. PWM signals are typically generated by an interrupt triggered by a timer with a fixed interval, based on the switching carrier frequency.

Therefore, it is desired to maintain this structure without creating complementary high-side PWM signals. The capacitance of  $V_{DD}$  should be sufficient to supply necessary charge to  $V_{BS}$  capacitance in all three phases. If a normal PWM operation starts before  $V_{BS}$  reaches  $V_{UVLO}$  reset level, the high-side IGBTs

cannot switch without creating a fault signal. It may lead to a failure of motor start in some applications. If three phases are charged synchronously, initial charging current through a single shunt resistor may exceed the over-current protection level.

Therefore, initial charging time for bootstrap capacitors should be separated, as shown in Figure 32. The effect of the bootstrap capacitance factor and charging method (low-side IGBT driving method) is shown in Figure 30.

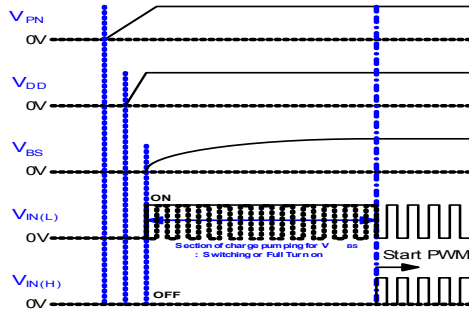


Figure 31. Timing Chart of Initial Bootstrap Charging

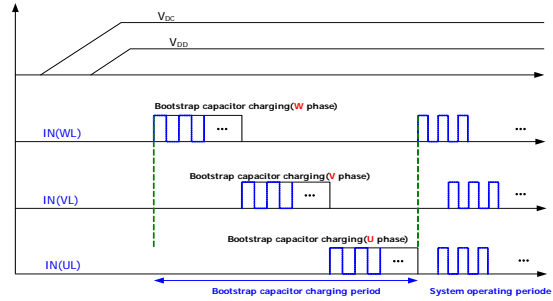


Figure 32. Recommended Initial Bootstrap Capacitors Charging Sequence

Figure 33 and Figure 34 shows waveform initial bootstrap capacitor charging voltage and current.

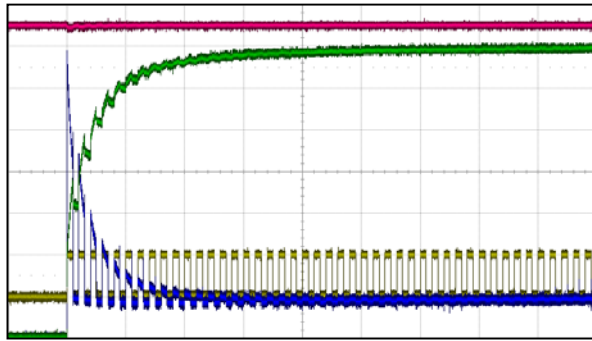


Figure 33. Each Part Initial Operating Waveform of Bootstrap Circuit (Conditions:  $V_{DC}=300\text{ V}$ ,  $V_{DD}=15\text{ V}$ ,  $C_{BS}=22\text{ }\mu\text{F}$ , LS IGBT Turn-on Duty=200  $\mu\text{sec}$ )

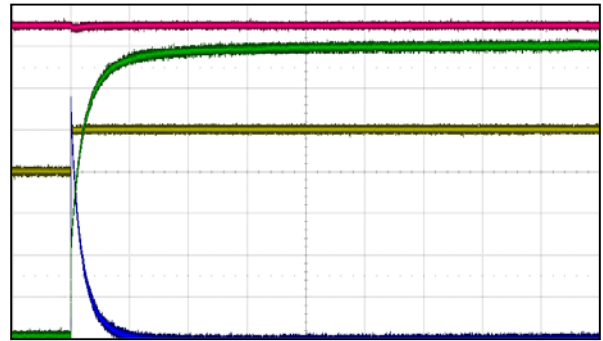


Figure 34. Each Part Operating Waveform of Bootstrap Circuit (Conditions:  $V_{DC}=300\text{ V}$ ,  $V_{DD}=15\text{ V}$ ,  $C_{BS}=22\text{ }\mu\text{F}$ , LS IGBT Full Turn-on)

### 6.5.3. Selection of Bootstrap Capacitor Considering Operating

The bootstrap capacitance can be calculated by:

$$C_{BS} = \frac{I_{leak} \times \Delta t}{\Delta V_{BS}} \quad (2)$$

Where:

$\Delta t$ : maximum on pulse width of high-side IGBT;

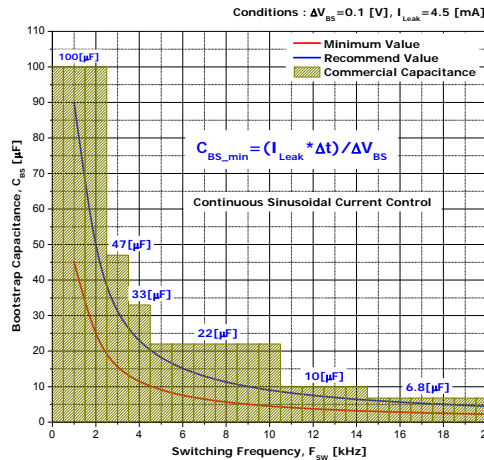
$\Delta V_{BS}$ : the allowable discharge voltage of the CBS (voltage ripple); and

$I_{leak}$ : maximum discharge current of the  $C_{BS}$ .

Mainly via the following mechanisms:

- Gate charge for turning the high-side IGBT on.
- Quiescent current to the high-side circuit in HVIC.
- Level-shift charge required by level-shifters in HVIC.
- Leakage current in the bootstrap diode.
- $C_{BS}$  capacitor leakage current (ignored for non-electrolytic capacitors).
- Bootstrap diode reverse recovery charge.

Practically, 4.5mA of  $I_{Leak}$  is recommended for the 600V SPM3 version 6 series. By considering dispersion and reliability, the capacitance is generally selected to be 2~3 times the calculated one. The CBS is only charged when the high-side IGBT is off and the  $V_{S(x)}$  voltage is pulled down to ground. The on-time of the low-side IGBT must be sufficient to for the charge drawn from the CBS capacitor to be fully replenished. This creates an inherent minimum on-time of the low-side IGBT (or off-time of the high-side IGBT).



**Figure 35. Capacitance of Bootstrap Capacitor on Variation of Switching Frequency**

Based on switching frequency and recommended  $\Delta V_{BS}$ .

- $I_{Leak}$ : circuit current = 4.5mA (recommended value)
- $\Delta V_{BS}$ : discharged voltage = 1.0 V (recommended value)
- $\Delta t$ : maximum on pulse width of high-side IGBT = 0.2 ms (depends on application)

$$C_{BS\_min} = \frac{I_{Leak} \times \Delta t}{\Delta V_{BS}} = \frac{2mA \times 4.5ms}{1.0V} = 9.0 \times 10^{-6}$$

→ More than 2 times → 18μF.

**Note:**

41. The capacitance value can be changed according to the switching frequency, the capacitor selected, and the recommended  $V_{BS}$  voltage of 13.0~18.5 V (from datasheet). The above result is just a calculation example. This value can be changed according to the actual control method and lifetime of the component.

#### 6.5.4. Built-in Bootstrap Diode

When the high-side IGBT or diode conducts, the bootstrap diode ( $D_{BS}$ ) supports the entire bus voltage. Hence, a diode with withstand voltage of more than 600 V is recommended. It is important that this diode has a fast recovery (recovery time < 100 ns) characteristic to minimize the amount of charge fed back from the bootstrap capacitor into the  $V_{DD}$  supply. The bootstrap resistor ( $R_{BS}$ ) is to slow down the  $dV_{BS}/dt$  and limit initial charging current ( $I_{charge}$ ) of bootstrap capacitor.

Normally, a bootstrap circuit consists of bootstrap diode ( $D_{BS}$ ), bootstrap resistor ( $R_{BS}$ ), and bootstrap capacitor ( $C_{BS}$ ). As shown in Figure 36, the built-in bootstrap diode of SPM<sup>®</sup> 3 version 6 product has special  $V_F$  characteristics to be used without additional bootstrap resistor. Therefore, only external bootstrap capacitors are needed to make bootstrap circuit.

The characteristics of the built-in bootstrap diode in the SPM3 products are:

- Fast recovery diode: 600 V/0.5 A
- $t_{rr}$ : 80 ns (typical)
- Resistive characteristic: equivalent resistor of approximately 15 Ω

**Error! Reference source not found.** shows the absolute maximum ratings of bootstrap diode. **Error! Reference source not found.** shows forward voltage drop and reverse recovery characteristic of the bootstrap diode.



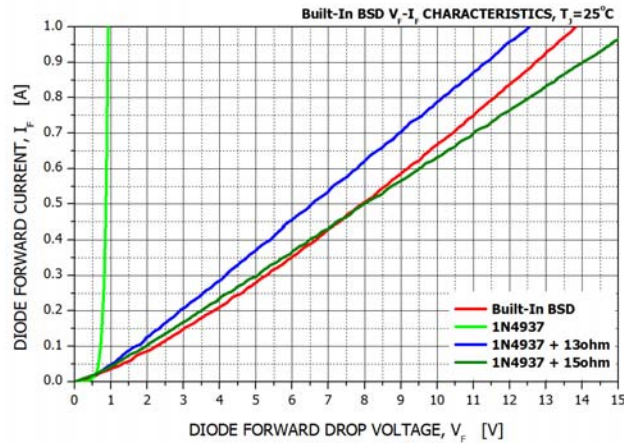


Figure 36. V-I characteristics of Bootstrap Diode in SPM3 Series products

## 7. Print Circuit Board (PCB) Design

### 7.1. General Application Circuit Example

Figure 37 shows a general application circuitry of interface schematic with control signals connected directly to a MCU. Figure 38 shows guidance of PCB layout for the 600V SPM<sup>®</sup>3 version 6 series.

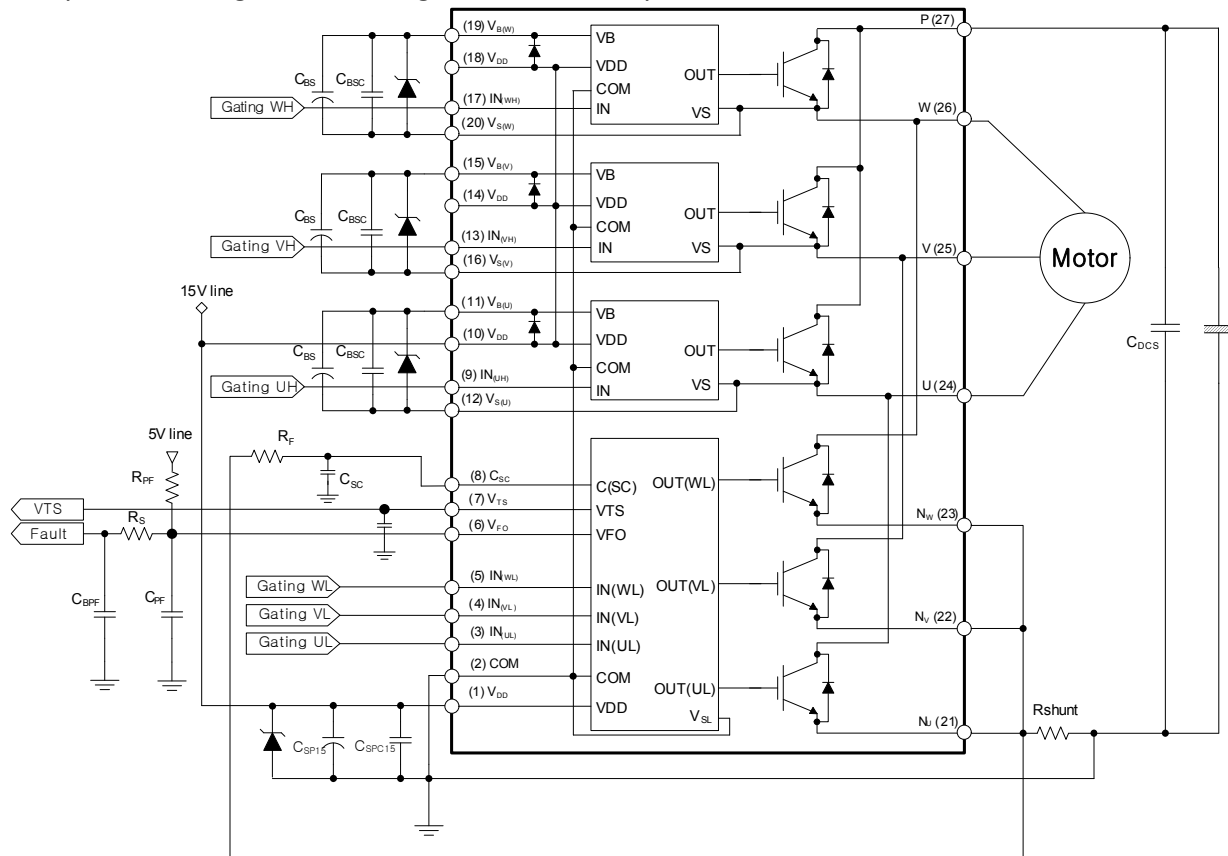


Figure 37. General Application Circuitry for 600V Motion SPM 3 Version 6



## 7.2. PCB Layout Guidance

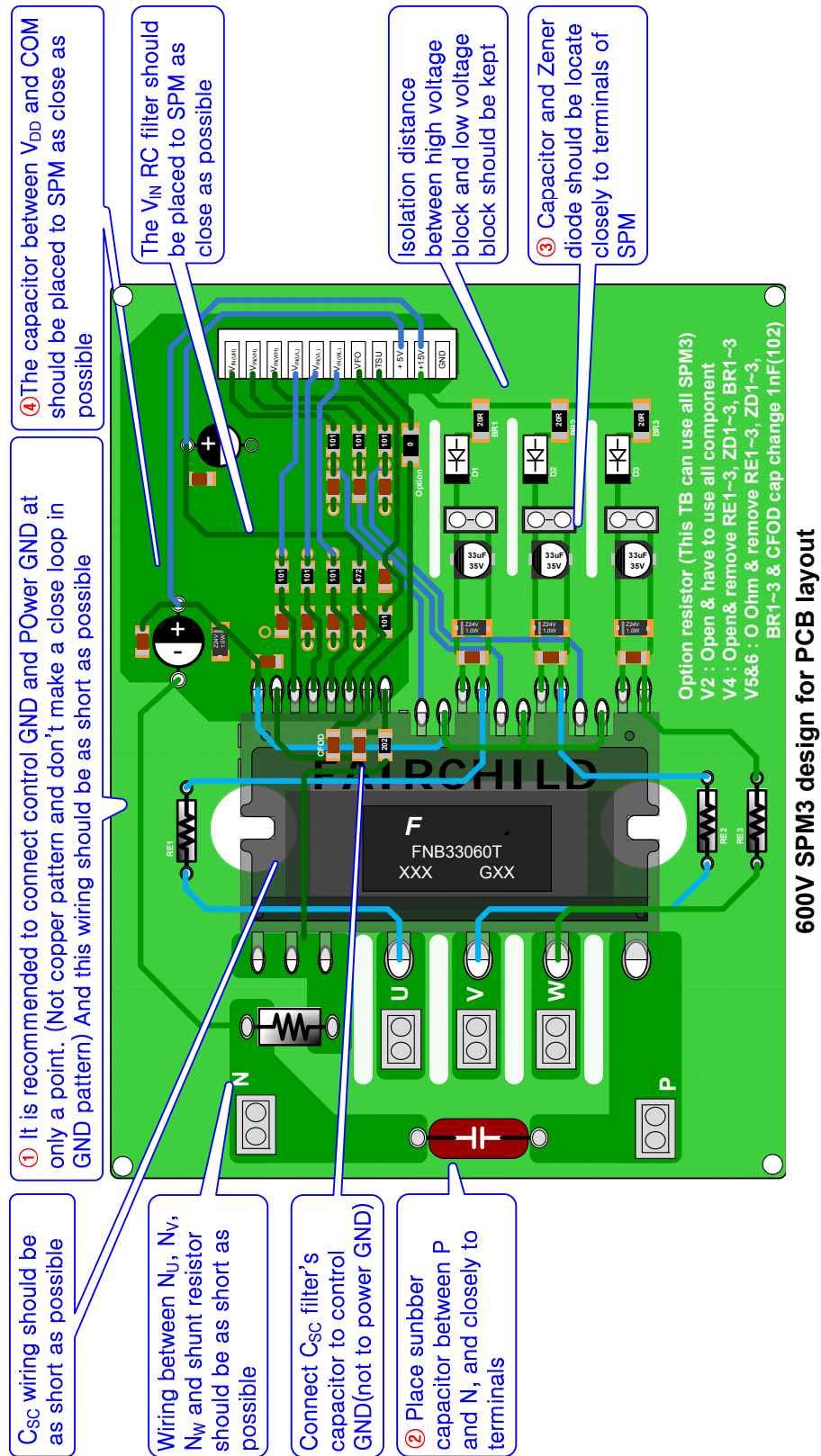
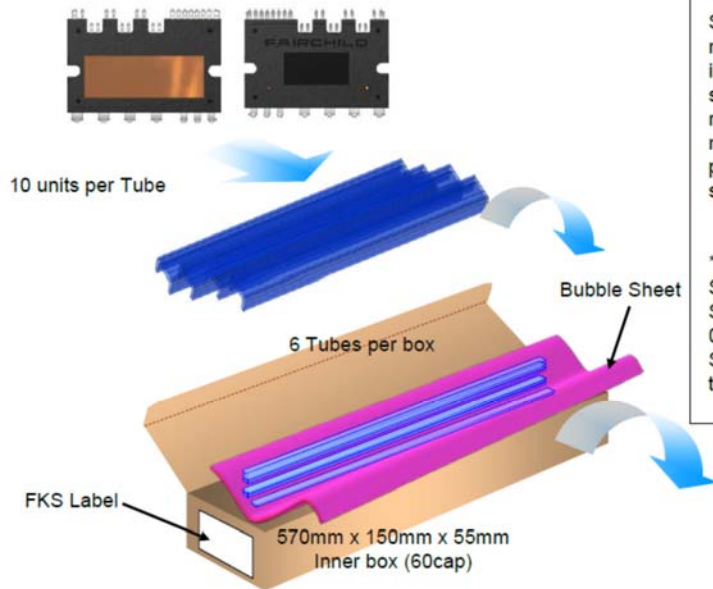


Figure 38. Print Circuit Board (PCB) Layout Guidance for the 600 V Motion SPM®3

## 8. Packing Information

### SPMCA-027 Tube Packing Configuration: Figure 1.0



#### Packaging Description:

SPMCA-027 parts are shipped normally in tube. The tube is made of PVC plastic treated with anti-static agent. These tubes in standard option are placed inside a dissipative plastic bubble sheet, barcode labeled, and placed inside a box made of recyclable corrugated paper. One box contains six tubes maximum (see fig. 1.0). And one or several of these boxes are placed inside a labeled shipping box which comes in different sizes depending on the number of parts shipped.

\* SPMCC-027, SPMCD-027, SPMCE-027, SPMCF-027, SPMCG-027, SPMEA-027, SPMEC-027, SPMGA-027, SPMGC-027, SPMHA-027, SPMHC-027, SPMIA-027, SPMIC-027, SPMMA-027, SPMMB-027, SPMMA-027, SPMQA-027, SPMQB-027, SPMRA-027, SPMRB-027 packages also use this packing spec.

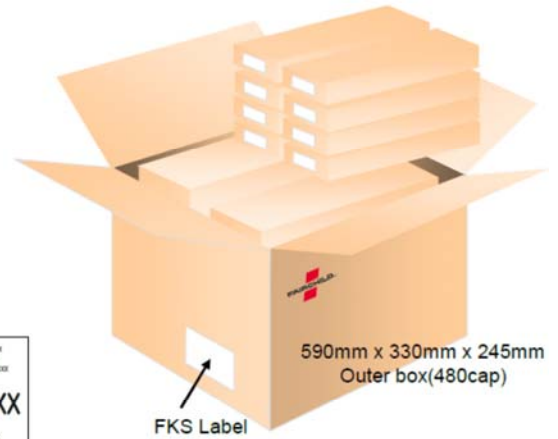
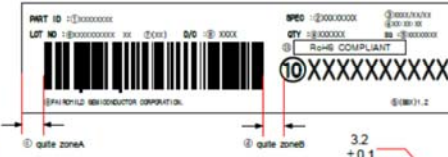
### SPMCA-027 Packaging Information: Figure 2.0

SPMCA-027 Packaging Information	
Packaging Option	Standard (no flow code)
Packaging type	Rail/Tube
Qty per Tube/ Inner Box	10
Inner Box Dimension (mm)	570x150x55
Max qty per Box	60
Outer Box Dimension (mm)	590x330x245
Max qty per Box	480
Weight per unit (gm)	-
Note/Comments	

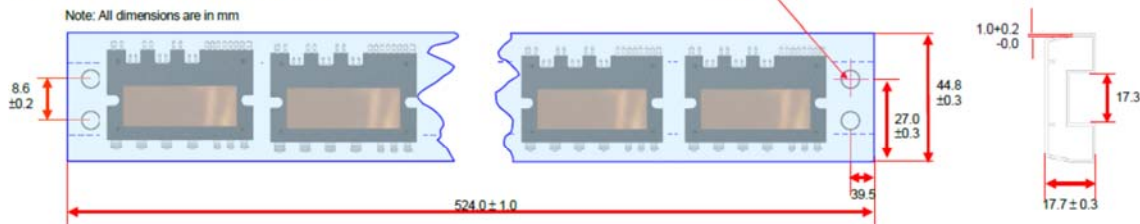
#### Inner Box Barcode Label Sample



#### Outer Box Barcode Label Sample



### SPMCA-027 Tube Information: Figure 3.0



#### NOTES:

- A : ALL DIMENSION ARE IN MILLIMETERS UNLESS OTHERWISE SPECIFIED
- B : DRAWING FILE NAME : PKG-MOD27BAREV2

Figure 39. Packing Information

## Related Resources

[FNB33060T Product Folder](#)

[AN-9086 — 600V SPM<sup>®</sup>3 Series Mounting Guidance](#)

[RD-572 — 600V SPM<sup>®</sup>3 ver6 series Reference Design Guide](#)

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